

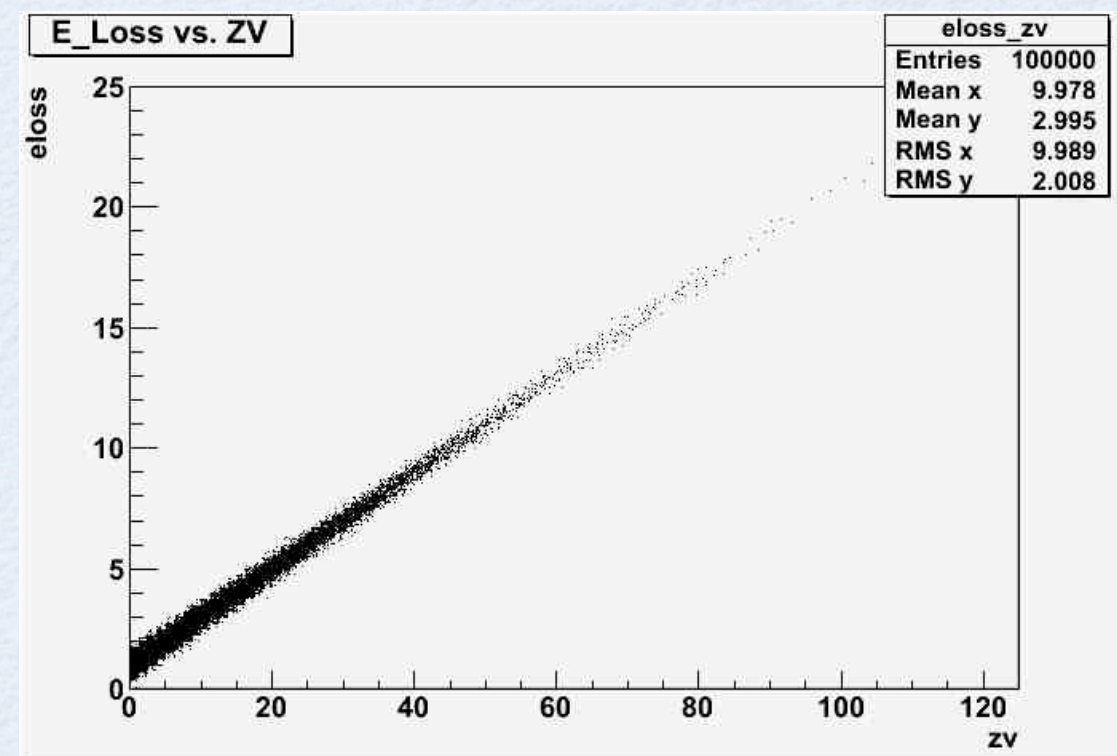
EVENT RECONSTRUCTION: TRACKING

FEW POINTS

- Most everyone did not get the 'randomness' part of homework one correctly.
- If you want to generate a random number from a distribution you can just generate a random number within the range of that function uniformly and then apply the function to each random number
- Only 2 people have sent me requests about what topic they would like to report on
 - I will start a doodle poll about when to do the presentation (towards the end of the class for the last couple weeks of the course)

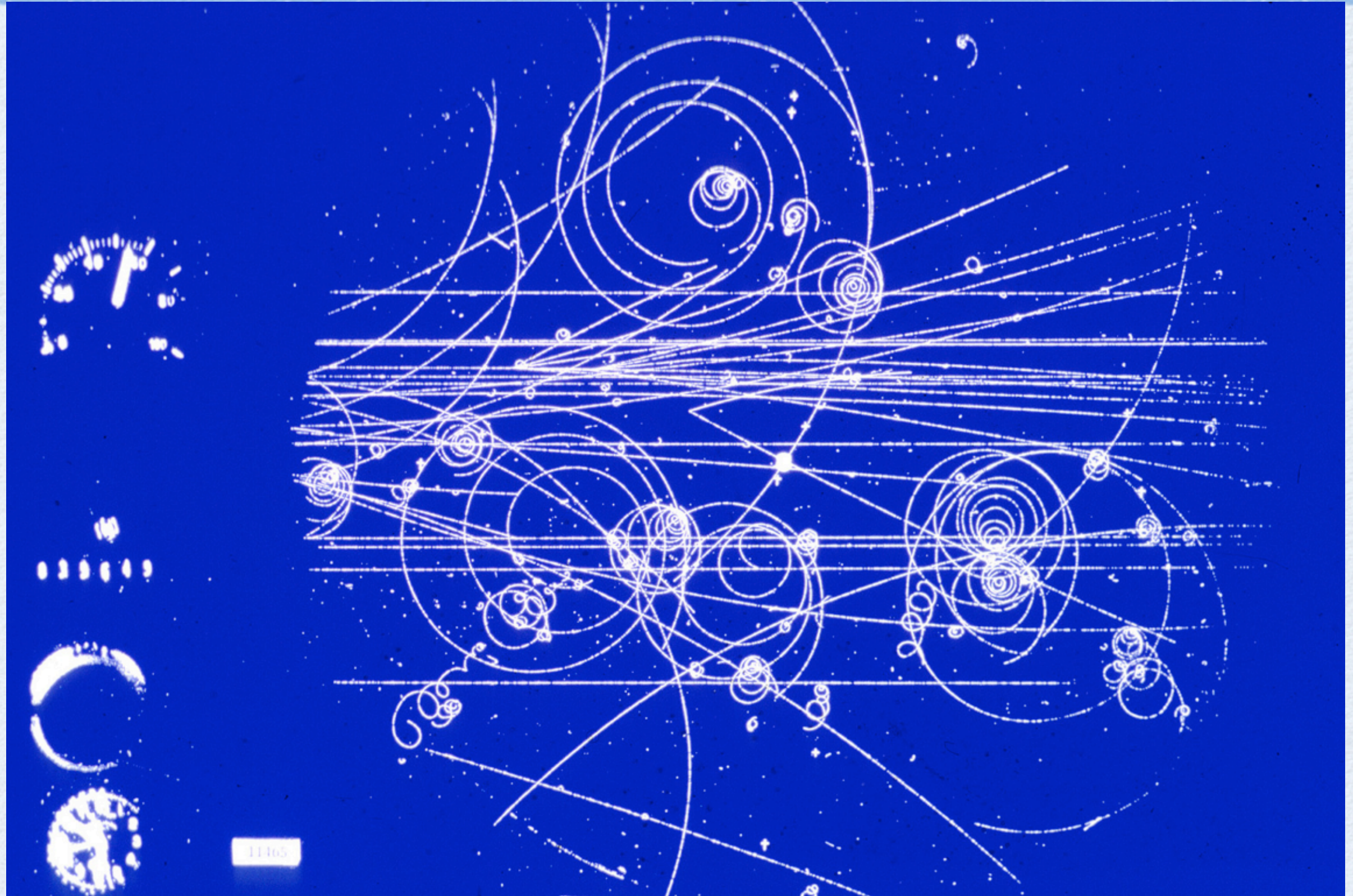
HOMework PROBLEM

- Choose bins of zv with roughly equal number of events
- Average the eloss for each of those bins
- Make a new histogram or TGraph plotting these versus each other
- Fit the result to a line

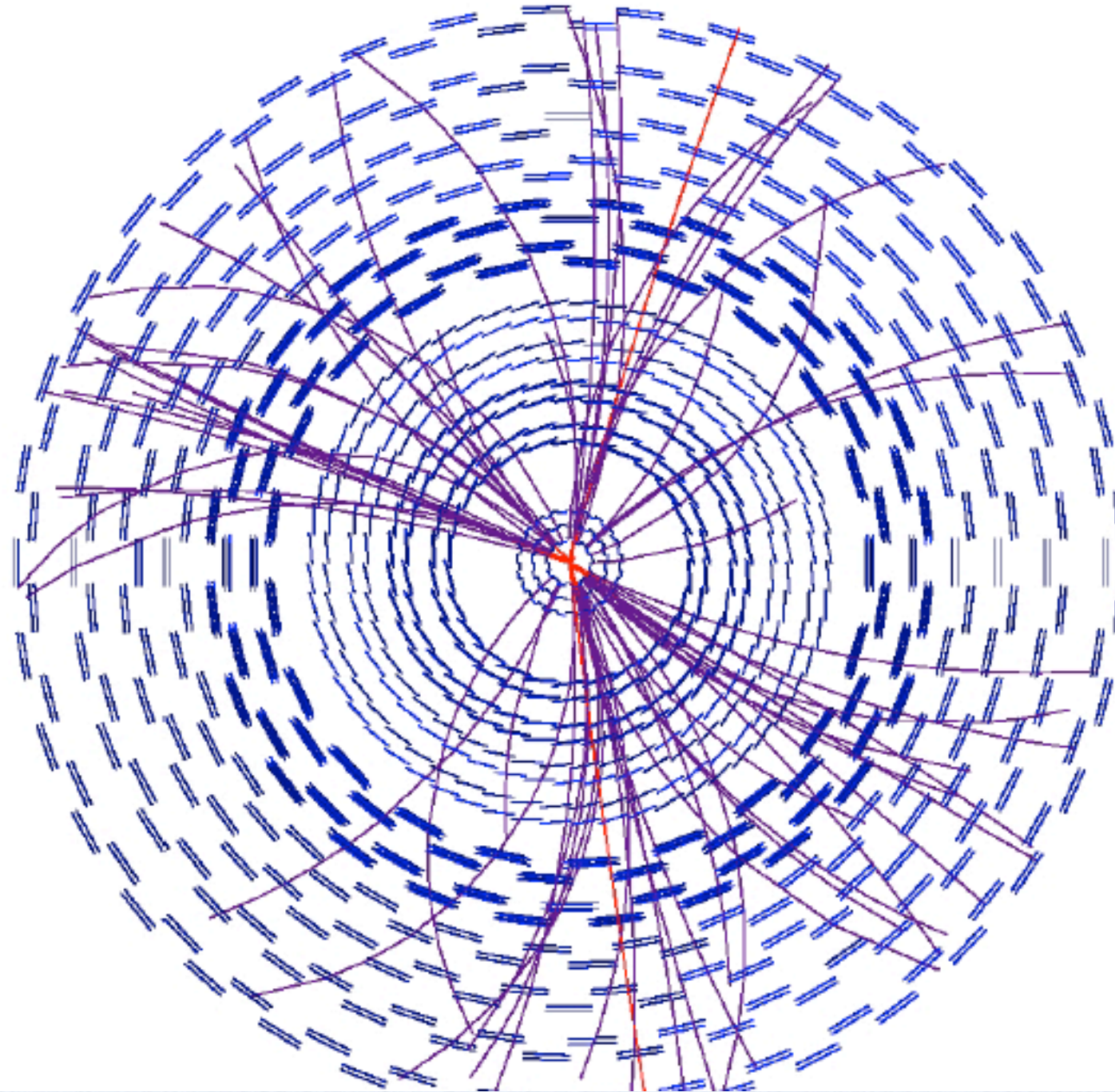


CERN BUBBLE CHAMBER

1960S



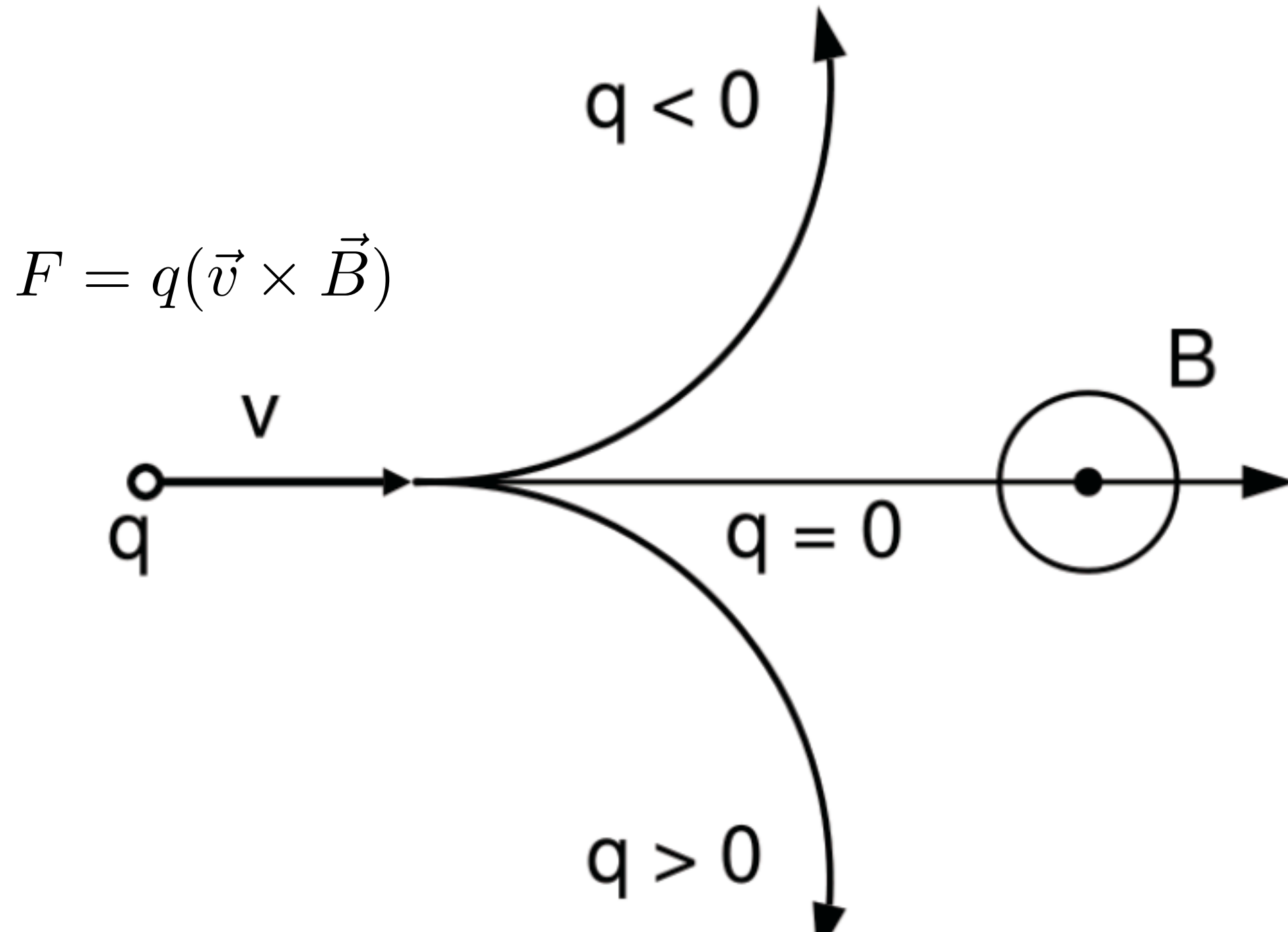
CMS TRACKING



TRACKING BASICS

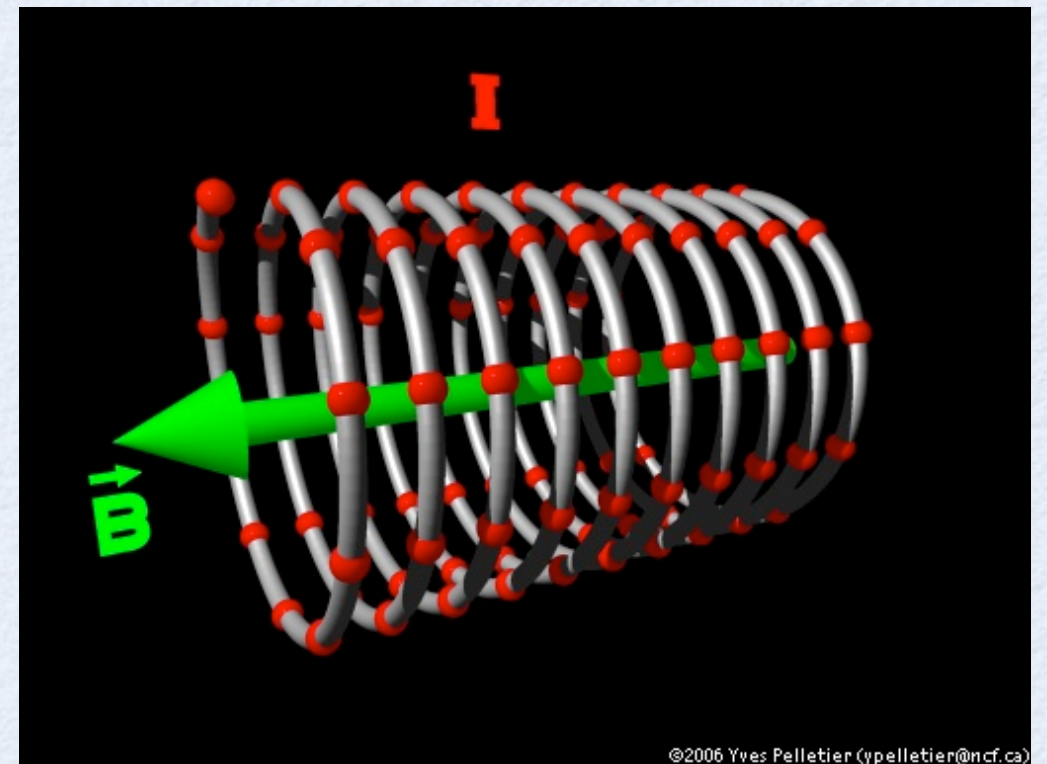
- When we talk about tracking we want to :
 - Measure the true path of the particle, which lets us know...
 - The momentum (3-momentum) if we know the field
 - The sign of the charge
 - The origin of the particle in space
 - without other information we cannot know the mass !

LORENTZ FORCE



PARTICLE TRAJECTORY

- For a charged particle produced at the center of the solenoid how can we describe its trajectory?



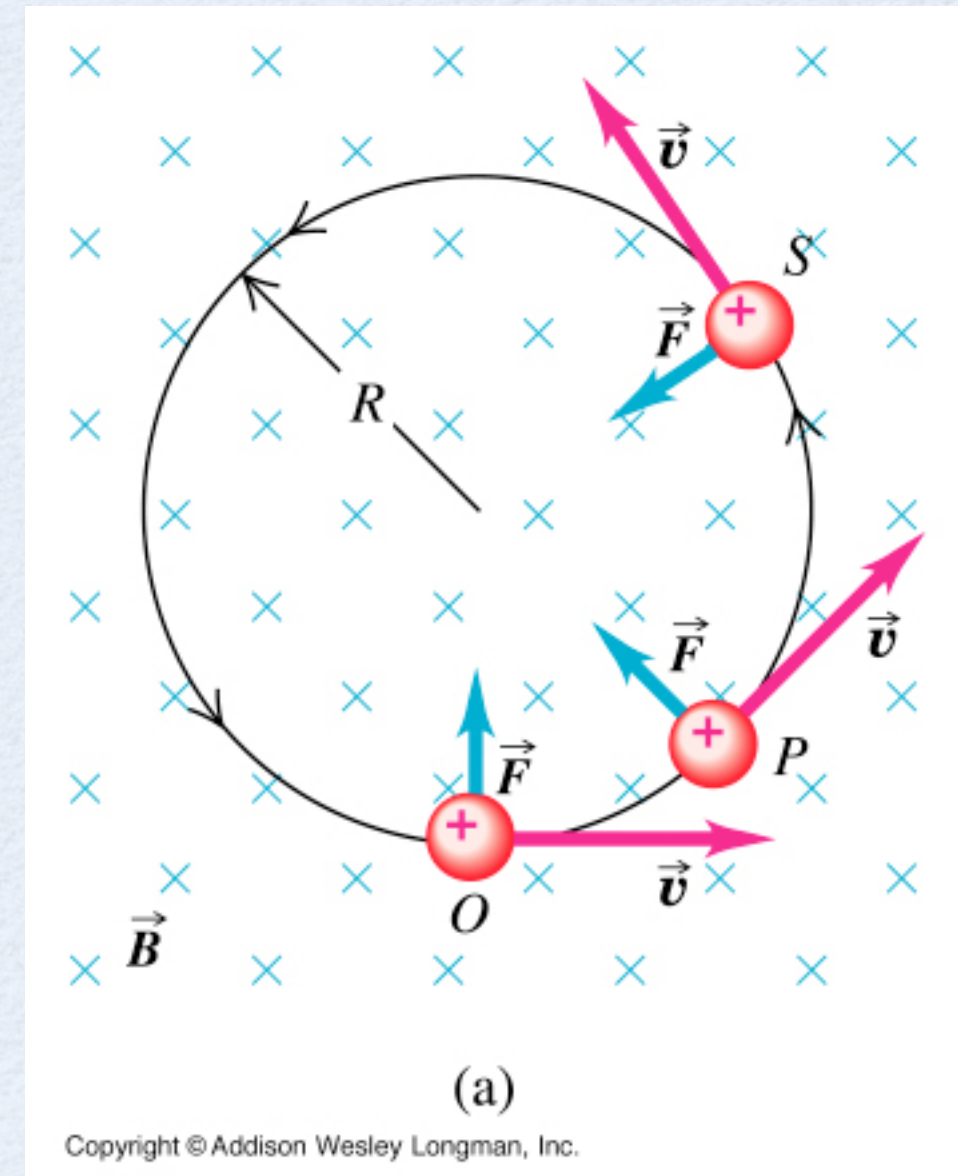
ASIDE

- Why is the inner magnet of a colliding beam experiment a solenoid?

IN 2-D

$$\vec{F} = q(\vec{v} \times \vec{B})$$

- The force and hence the acceleration are always perpendicular to the velocity so..



IN 3 DIMENSIONS

- For a solenoid surrounding the beam pipe we typically take the beam direction to be z - which is where B points

IN 3 DIMENSIONS

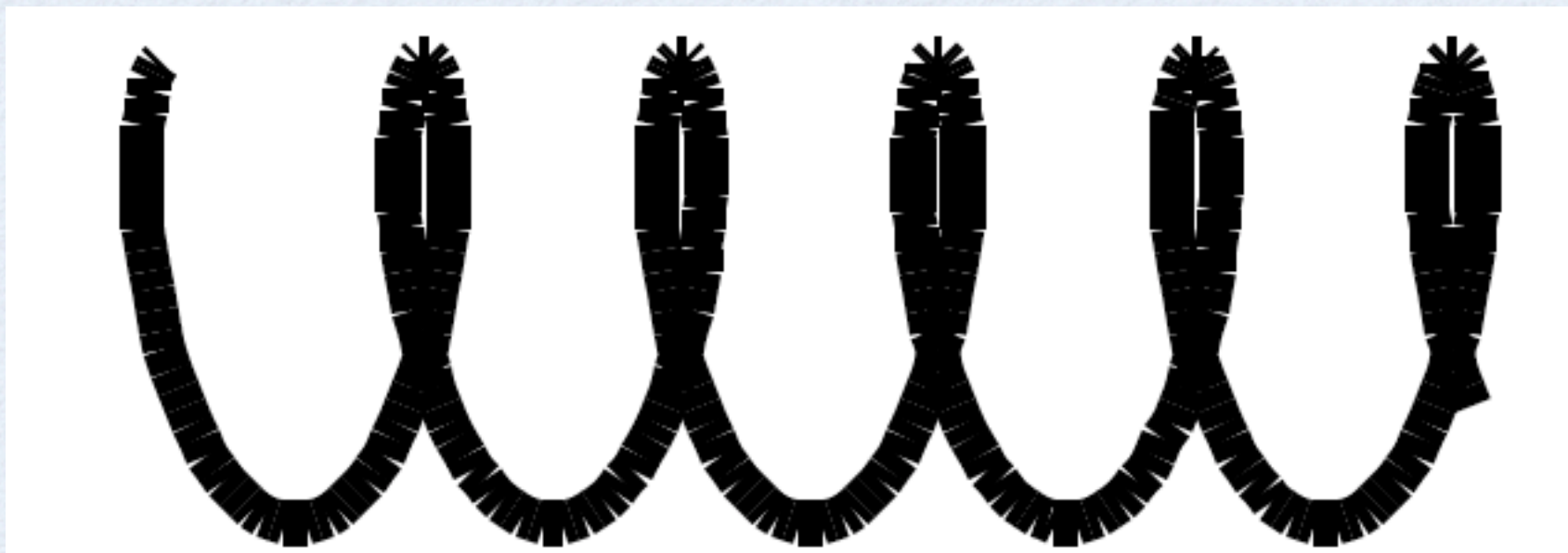
- For a solenoid surrounding the beam pipe we typically take the beam direction to be z - which is where B points
- The Lorentz force causes it to trace out a circle in the x,y plane but there is no force so it has constant velocity motion in the z direction

IN 3 DIMENSIONS

- For a solenoid surrounding the beam pipe we typically take the beam direction to be z - which is where B points
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- This means that the distance it travels in z is proportional to the arclength s that the particle traces out in the x,y plane

HELICAL TRACK

- For a solenoid surrounding the beam pipe we typically take the beam direction to be z - which is where B points
- The Lorentz force causes it to trace out a circle in the x,y plane but there is no force so it has constant velocity motion in the z direction
- This means that the distance it travels in z is proportional to the arclength s that the particle traces out in the x,y plane
- Think of the motion as a straight line in the s - z plane



HELIX PARAMETERS

- In spherical coordinates

$$p_x = p \cos\phi \sin\theta$$

$$p_y = p \sin\phi \sin\theta$$

$$p_z = p \cos\theta$$

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- In spherical coordinates
- Different experiments use different conventions for the ranges of the angles

$$p_x = p \cos\phi \sin\theta$$

$$p_y = p \sin\phi \sin\theta$$

$$p_z = p \cos\theta$$

$$\phi[-\pi, \pi]$$

$$\theta[0, \pi]$$

HELIX PARAMETERS

- In spherical coordinates
- Different experiments use different conventions for the ranges of the angles
- Also need a reference point for where the helix starts

$$p_x = p \cos\phi \sin\theta$$

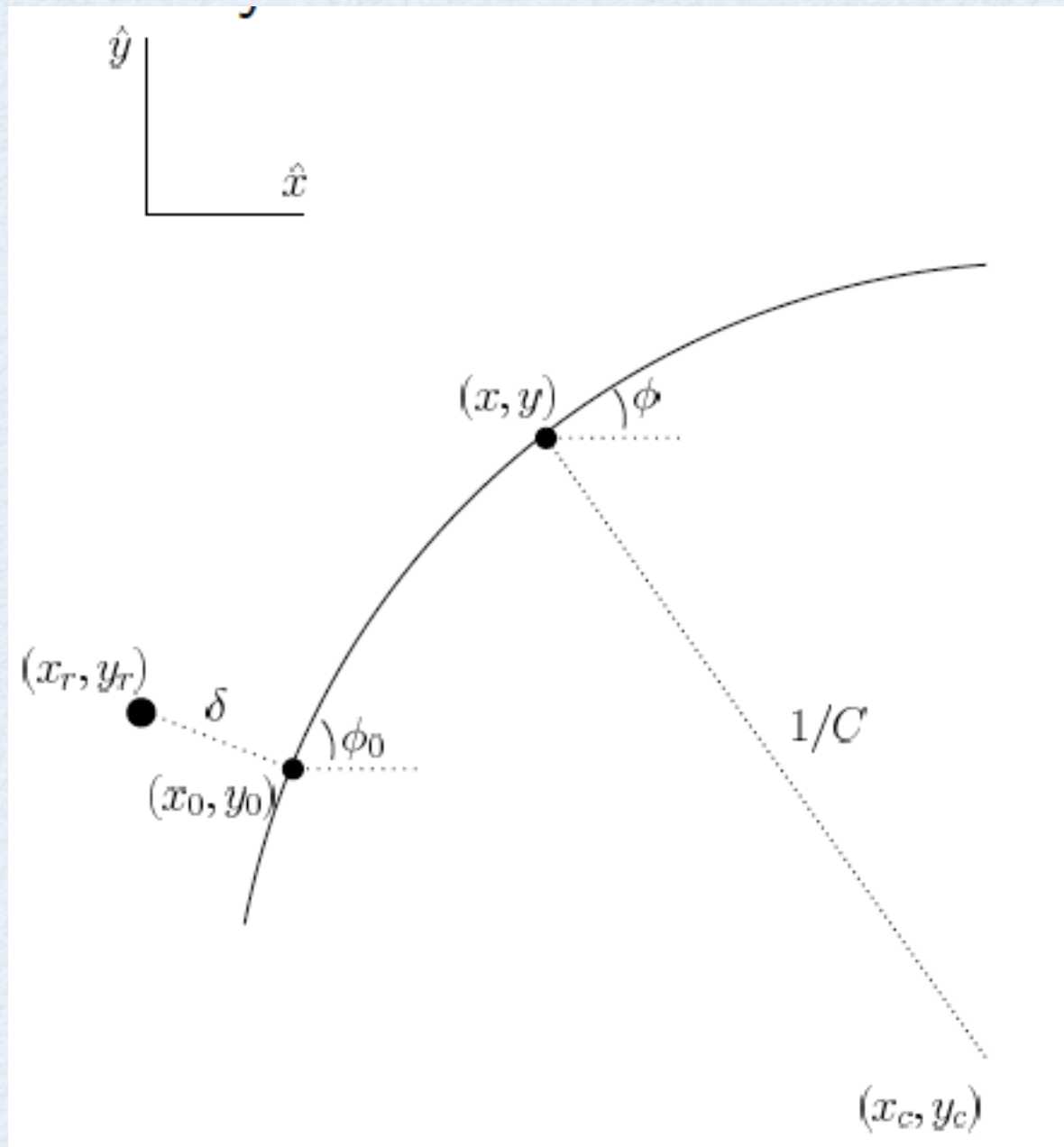
$$p_y = p \sin\phi \sin\theta$$

$$p_z = p \cos\theta$$

$$\phi[-\pi, \pi]$$

$$\theta[0, \pi]$$

PARAMETERS



- C = curvature of the track signed with the charge
- ϕ_0 = phi of track at distance of closet approach
- δ = distance of closet approach

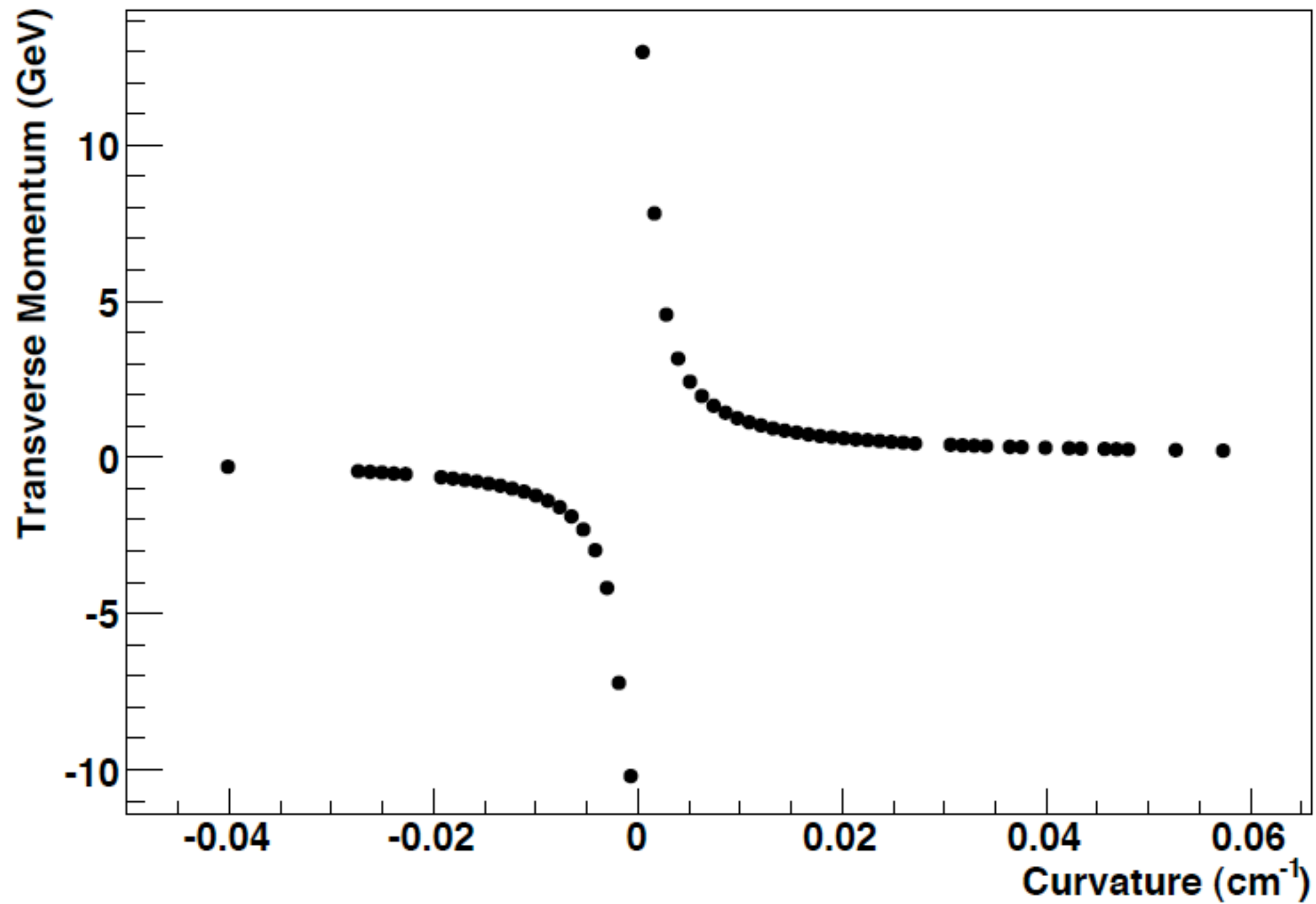
TRANSVERSE MOMENTUM

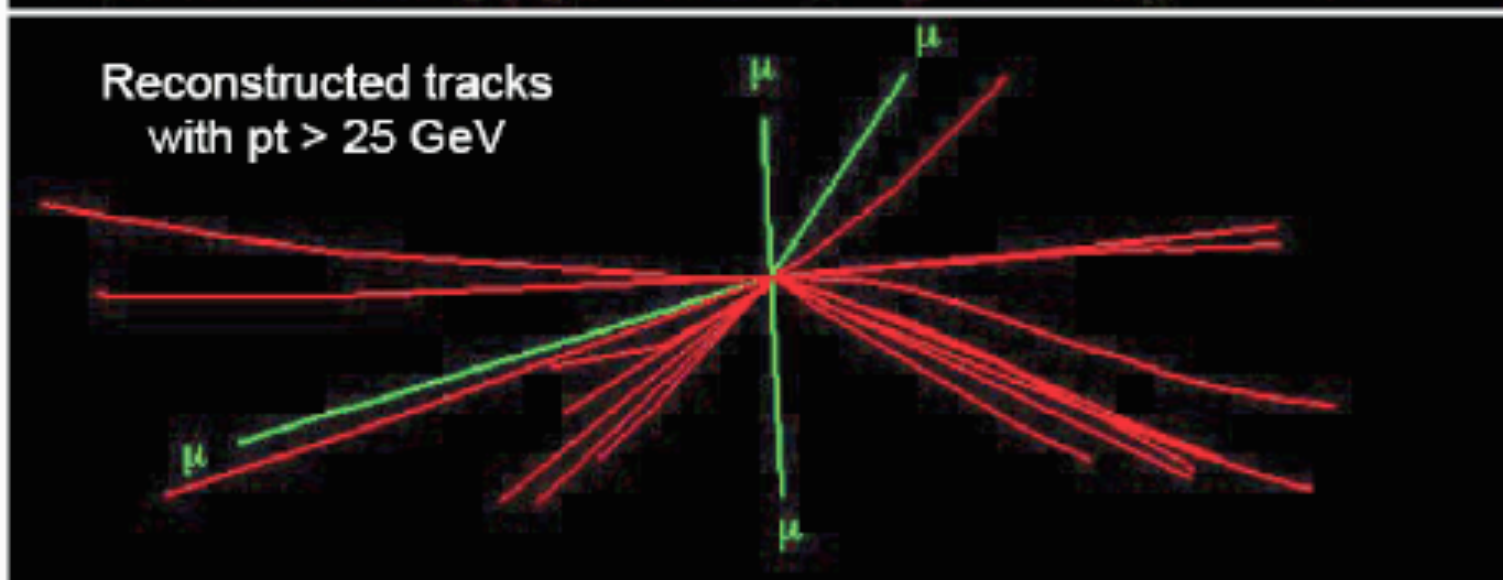
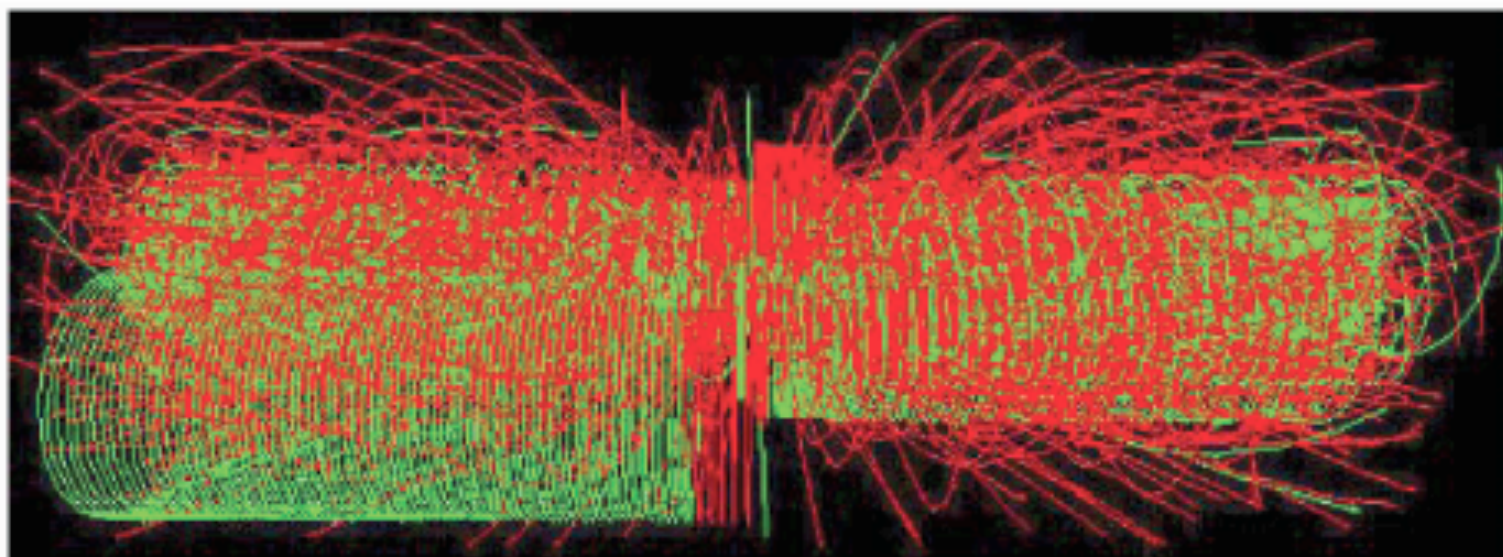
- The component of momentum in the plane transverse to the beam line

$$\begin{aligned} p_{\perp} [\text{GeV}] &= \frac{B[\text{kG}] \ c[\text{mm/s}] \ 10^{-10}}{C[\text{mm}^{-1}]} \\ &= \frac{B[\text{T}] \ c[\text{cm/s}] \ 10^{-13}}{C[\text{cm}^{-1}]} \\ p_{\perp} &= p \sin \theta \end{aligned}$$

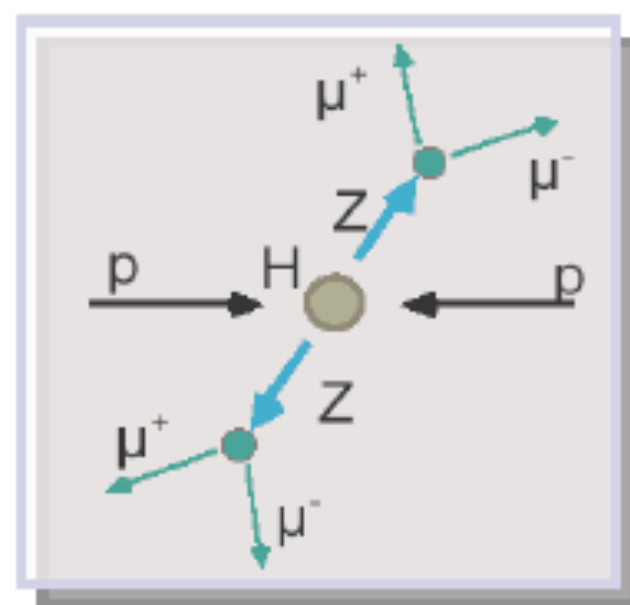
EXAMPLE

p_T vs Curvature in a 4T Homogeneous Field (CMS)

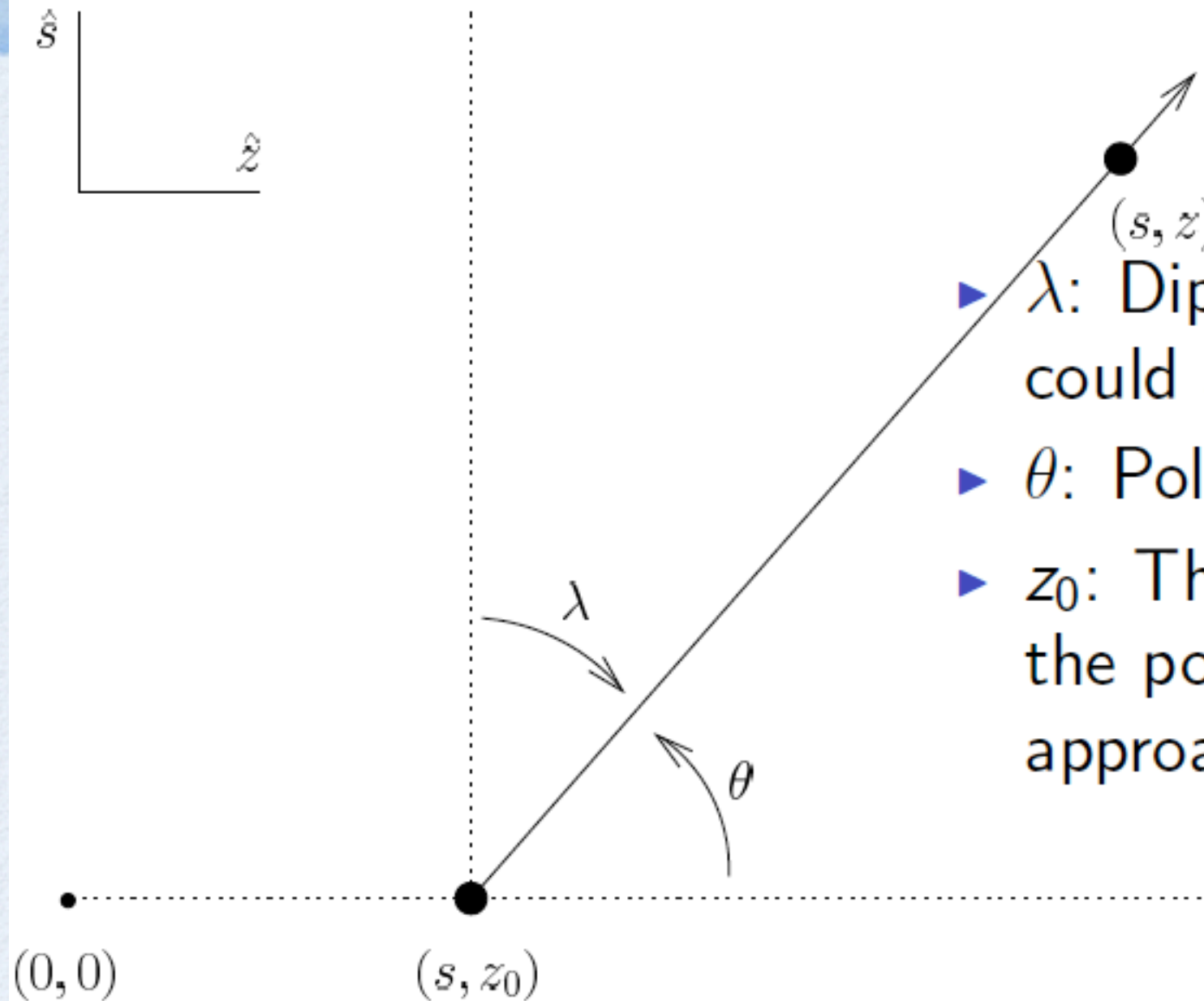




Higgs event
+
~25 minimum bias events



$$z = z_0 + s \tan \lambda$$



- ▶ λ : Dip angle of track, or could also use
- ▶ θ : Polar angle of track
- ▶ z_0 : The z of the track at the point of closest approach in $x - y$

ENERGY LOSS

- If a charged particle moves through material it can lose energy and slightly change direction

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- As a particle bends in a magnetic field it can emit radiation and lose energy

ENERGY LOSS

- If a charged particle moves through material it can lose energy and slightly change direction
- As a particle bends in a magnetic field it can emit radiation and lose energy
- Our model of the track trajectory must take these into account

TRACKING DETECTOR

- Should have the least amount of material as possible

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- Should have as many measurements of the trajectory as possible

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- Should be as cheap as possible

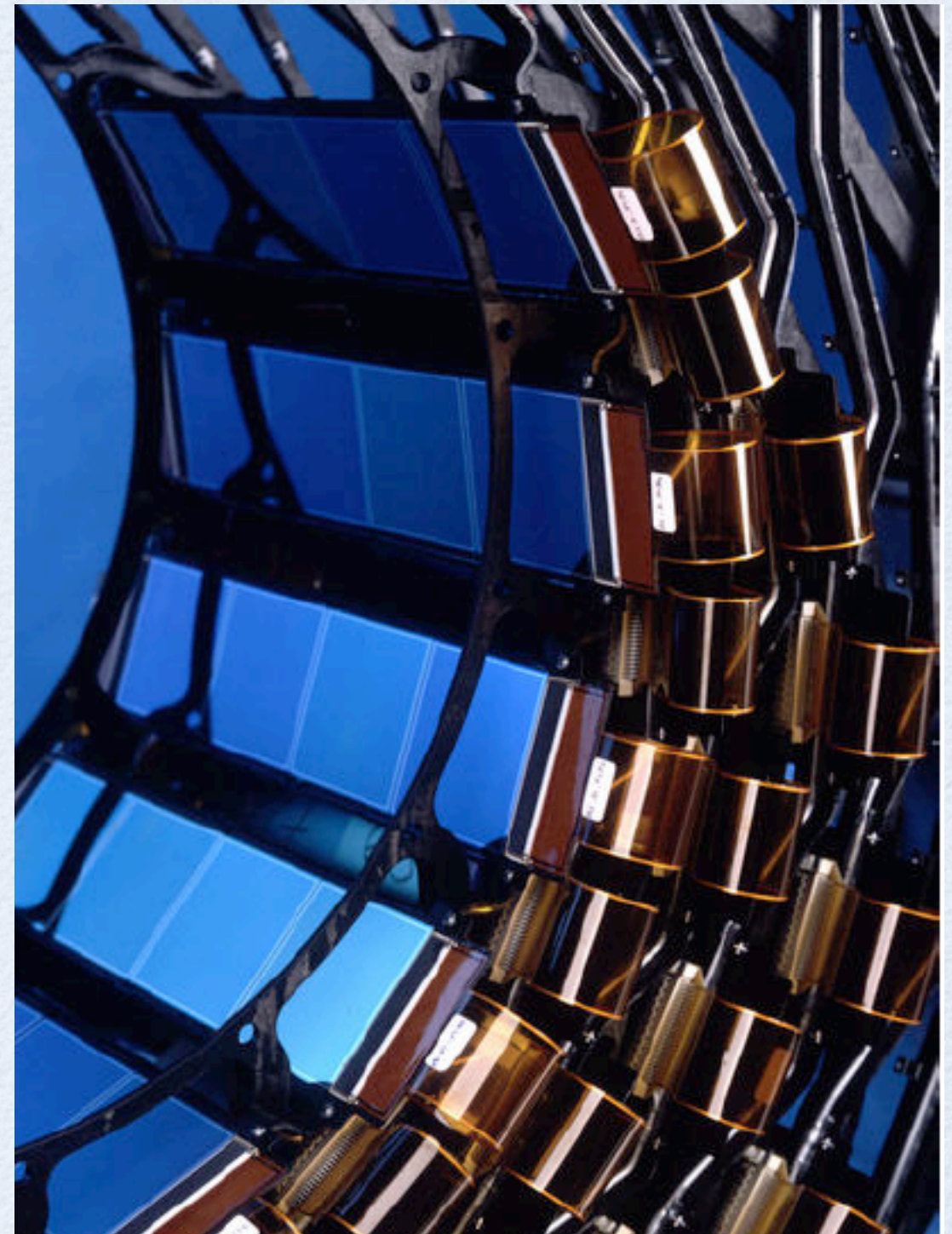
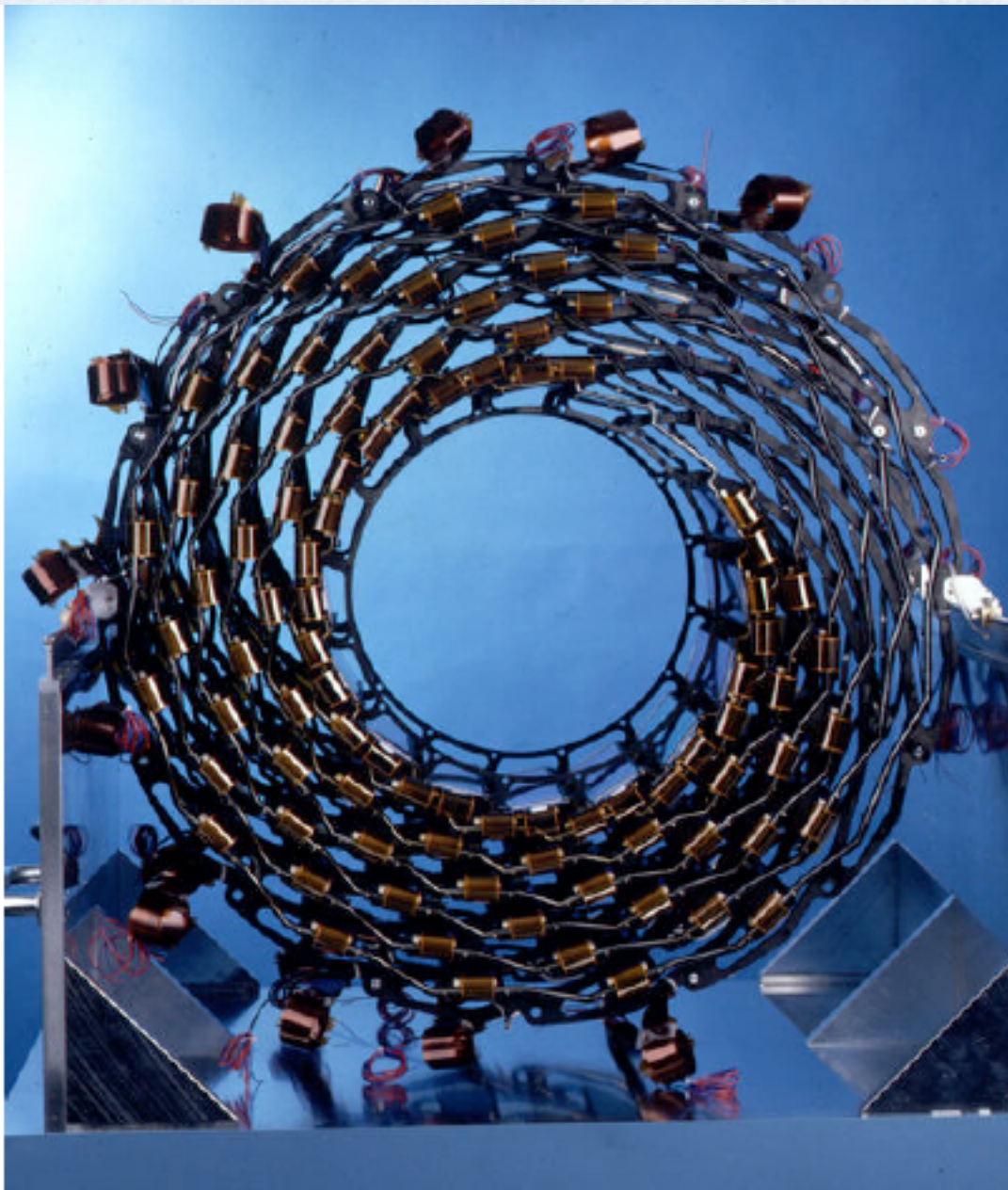
TRACKING DETECTOR

- Should have the least amount of material as possible
- Should have as many measurements of the trajectory as possible
- Should have as long a lever arm as possible
- Should have as large a magnetic field as possible
- Should be as cheap as possible
- Note - these are conflicting goals!!!

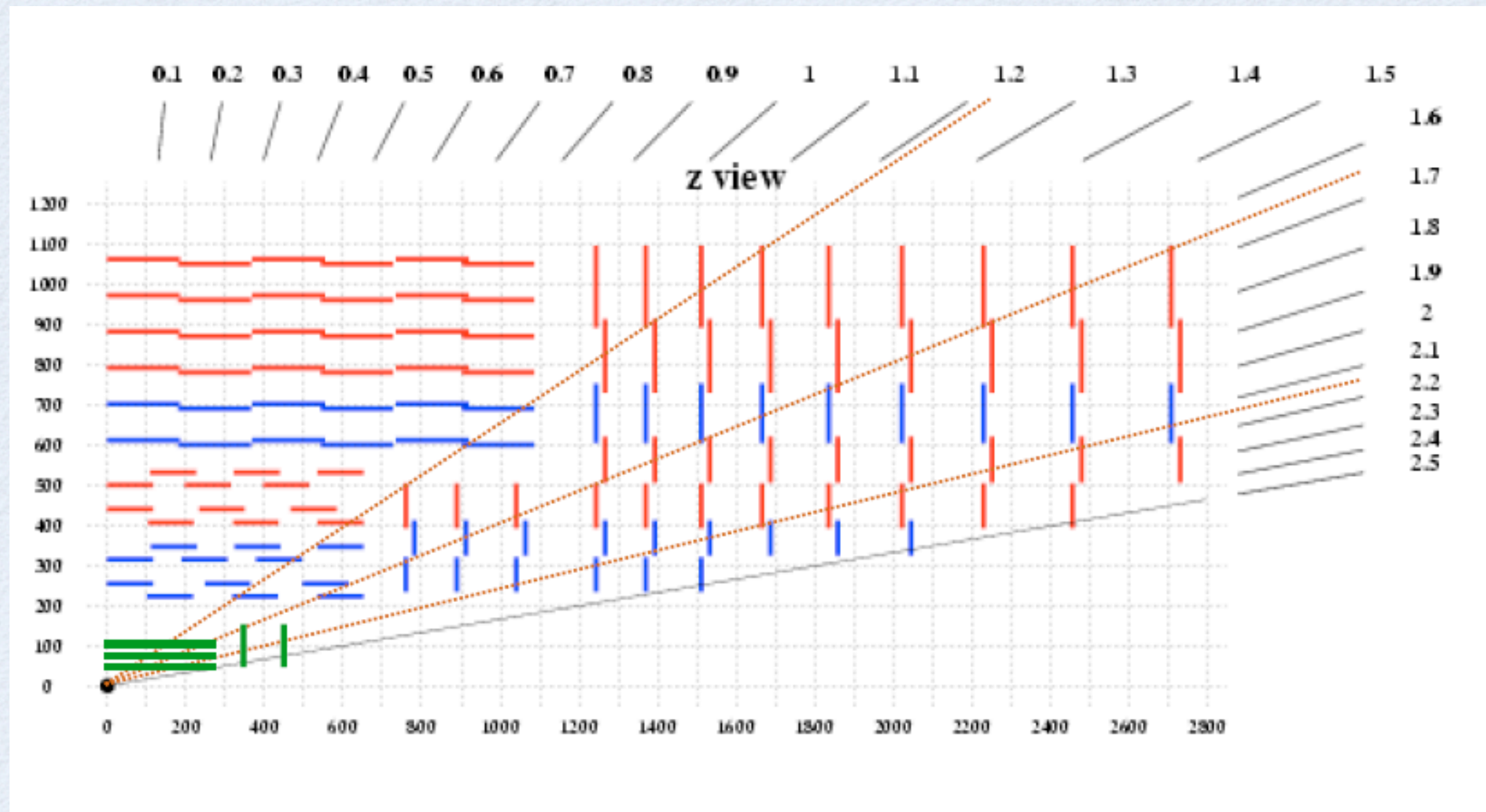
SOME TECHNOLOGIES

- Particle interacts with detector and convert energy loss into signal
- Gas and wires: ions in gas drift towards wire under influence of electric field
- Scintillating Fibers
- Silicon (reverse biased diode)

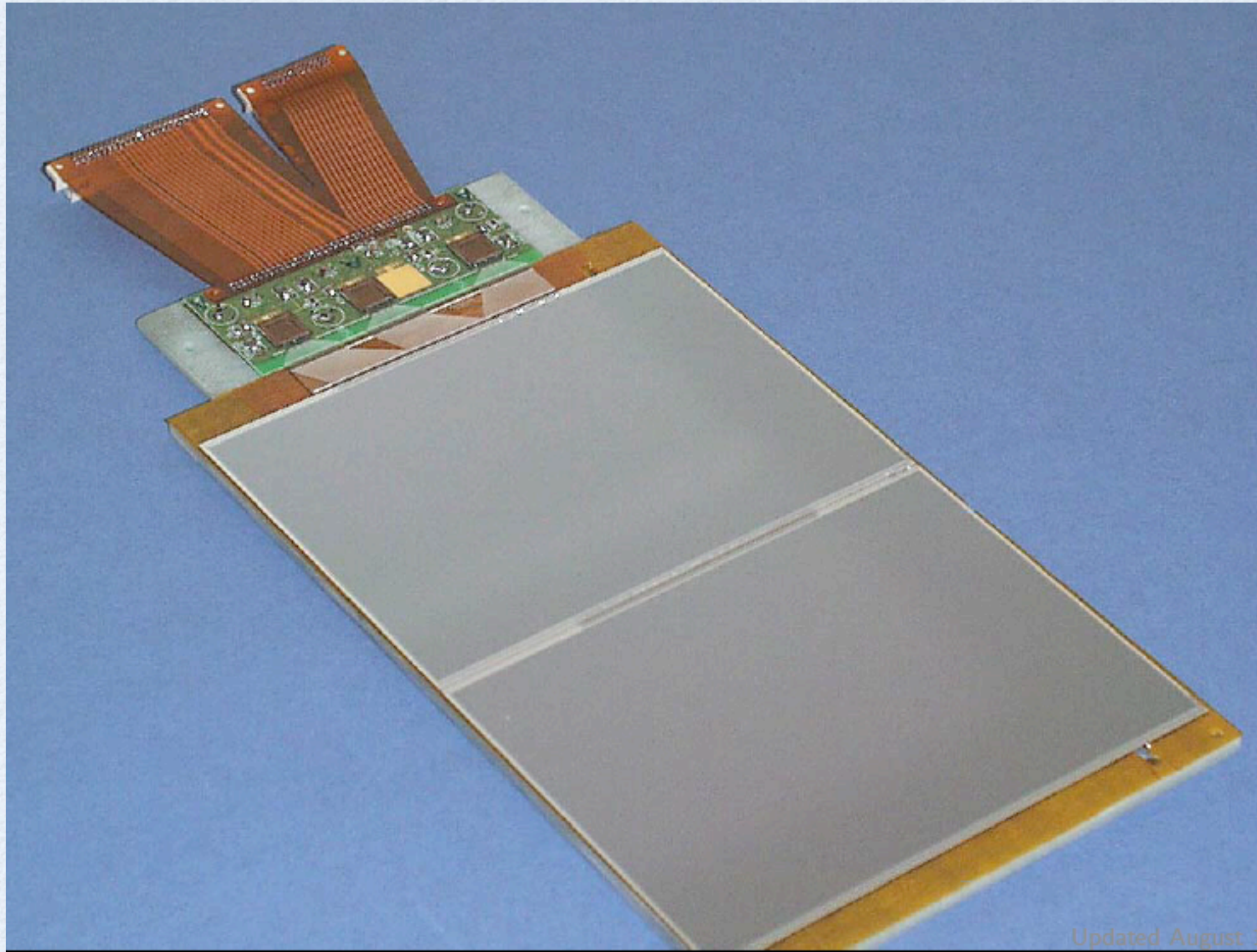
CMSTRACKER



CMS LAYOUT

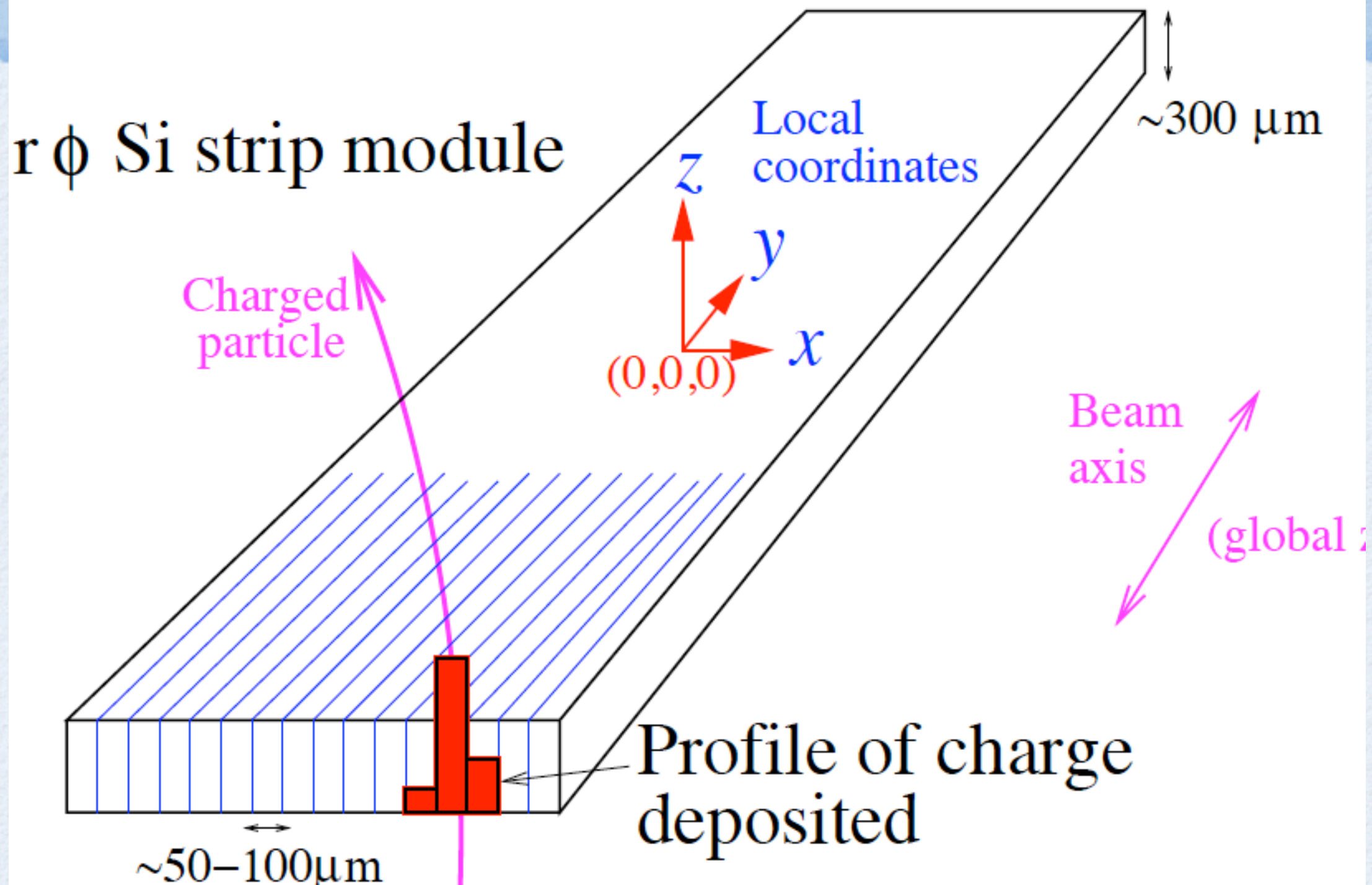


STRIP MODULE

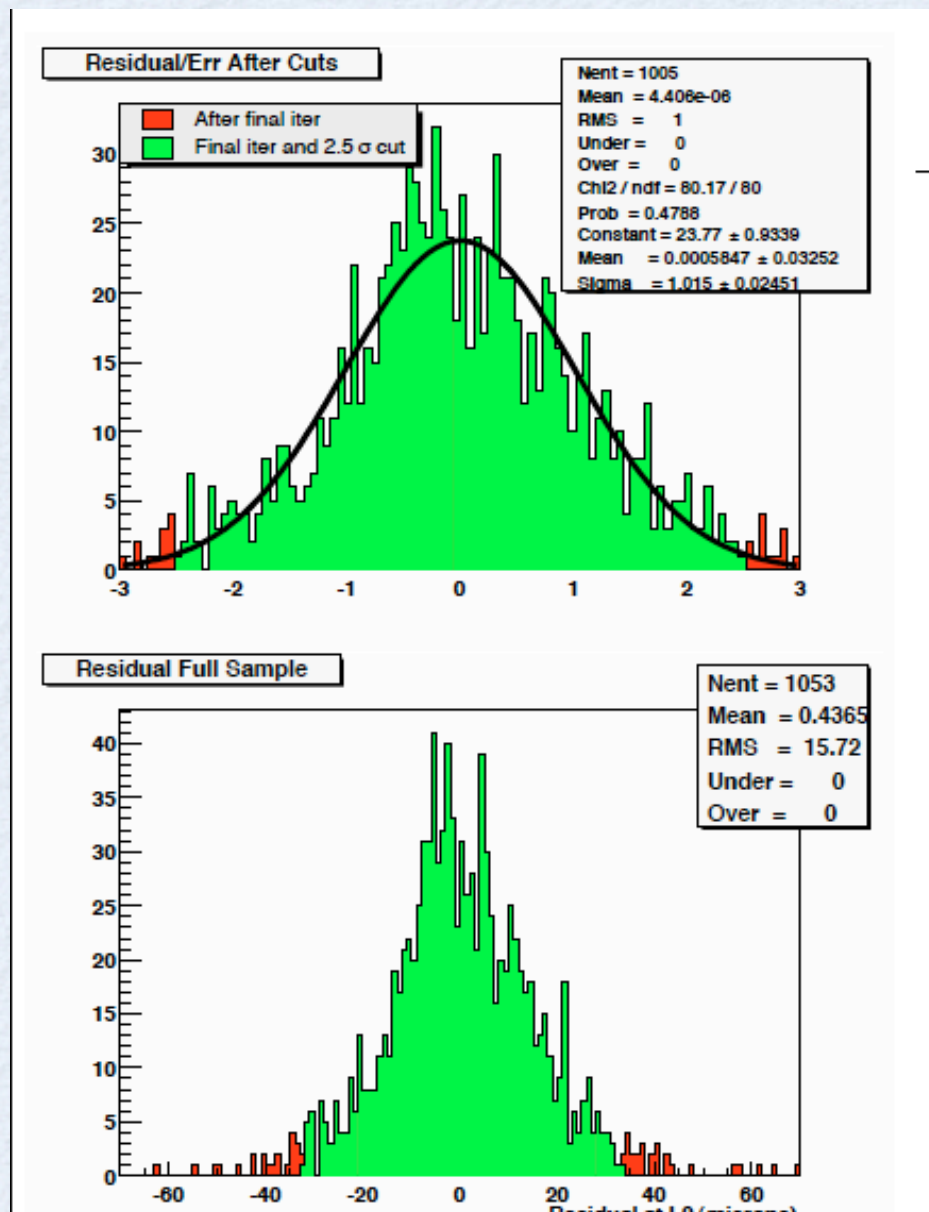


Updated August 1

2D Point ($r\phi$ or rz): $\bar{x} = (\sum i * q_i) / \sum q_i$

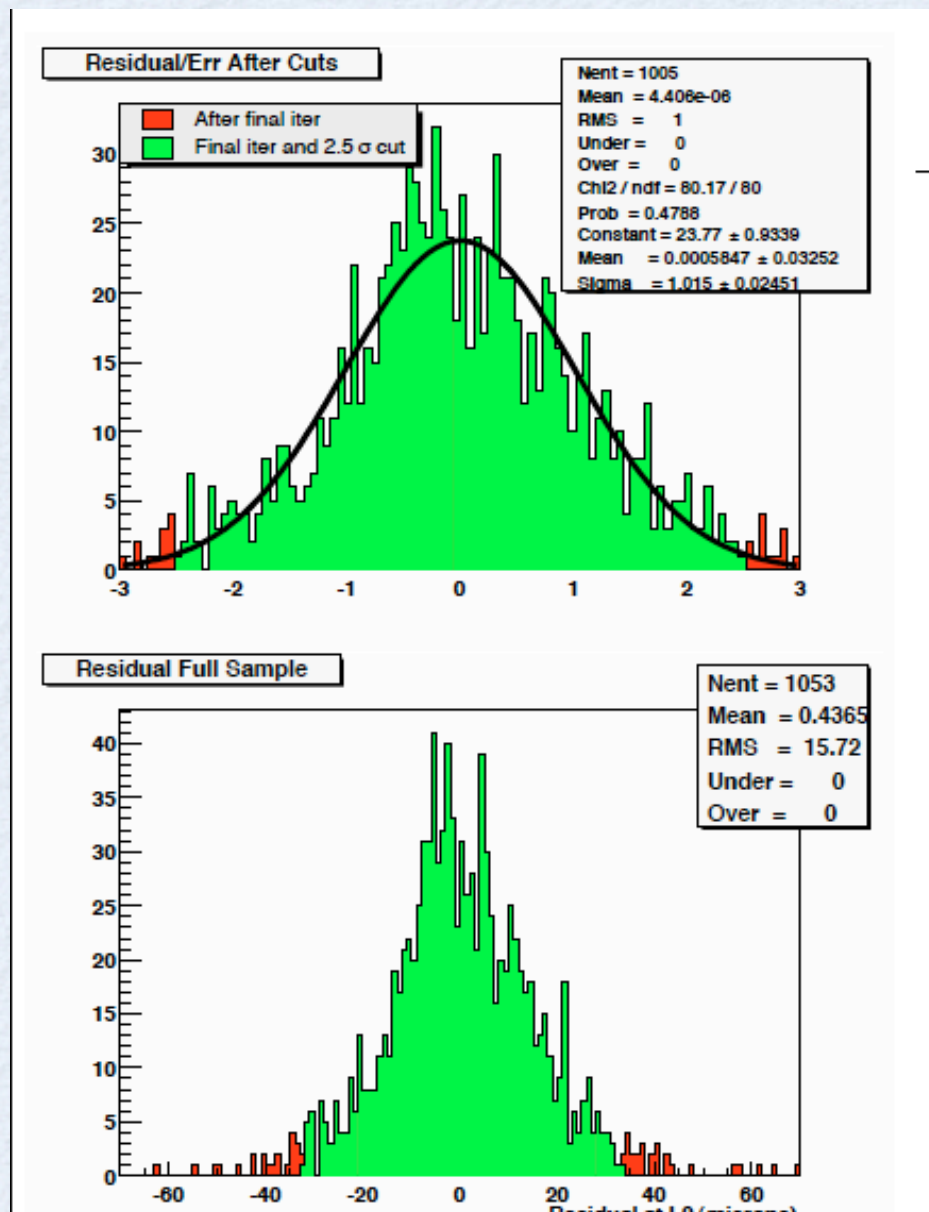


PRECISION OF SILICON WITH 50 MICRON PITCH



Cluster Width	Resolution
1	12 μm
2	9 μm
3	14 μm
4+	22 μm

PRECISION OF SILICON WITH ~ 50 MICRON PITCH

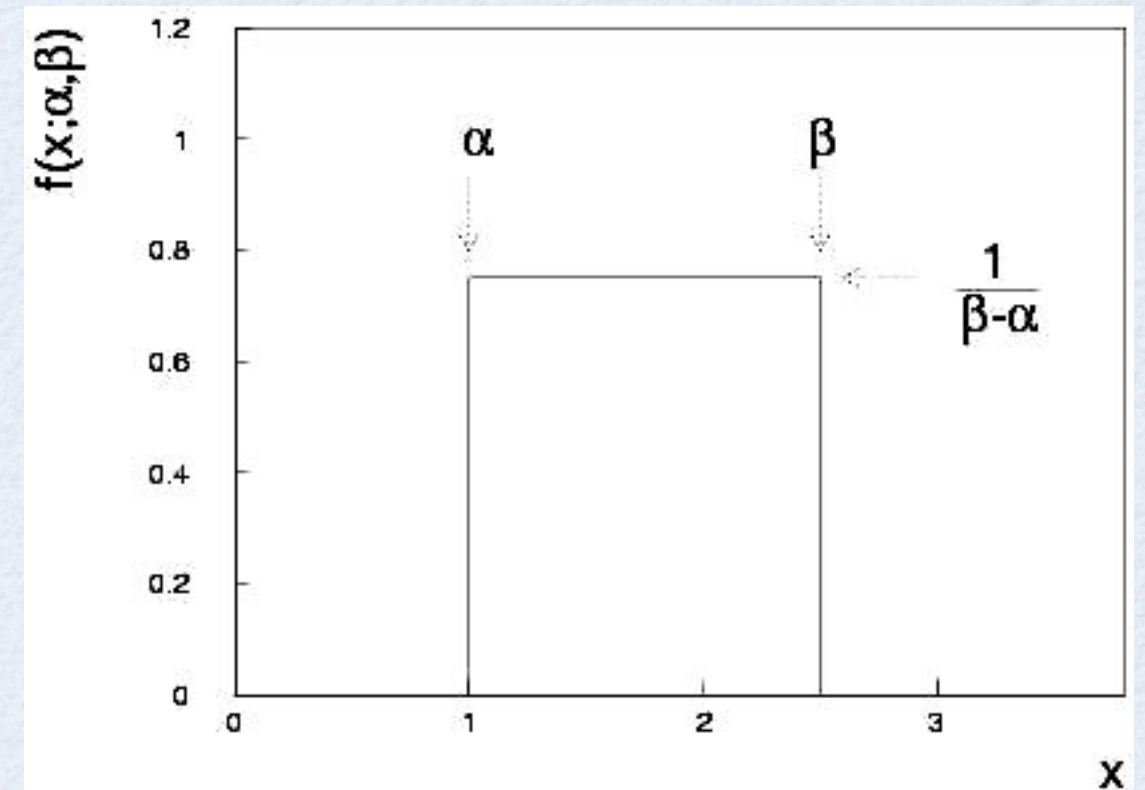


Cluster Width	Resolution
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Why is the 2 strip cluster
the most precise?

ASIDE: UNIFORM DISTRIBUTION

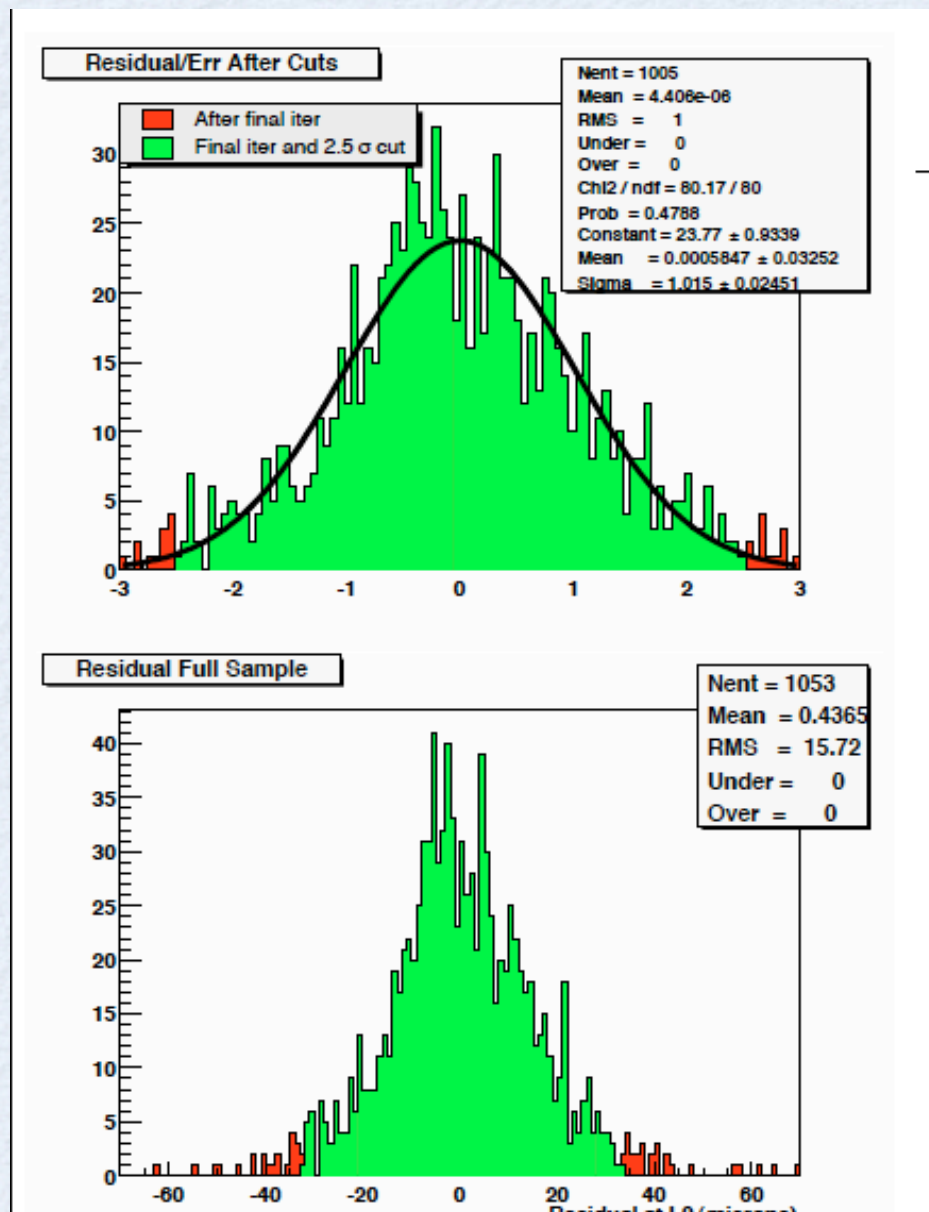
- Consider the uniform distribution which is constant between a lower and upper limit
- Not surprisingly the expectation value is just in the exact middle
- Perhaps surprisingly the standard deviation is the range/sqrt(12)
 - prove this for the homework!



$$E[x] = \frac{1}{2}(\alpha + \beta)$$

$$V[x] = \frac{1}{12}(\beta - \alpha)^2$$

PRECISION OF SILICON WITH ~ 50 MICRON PITCH

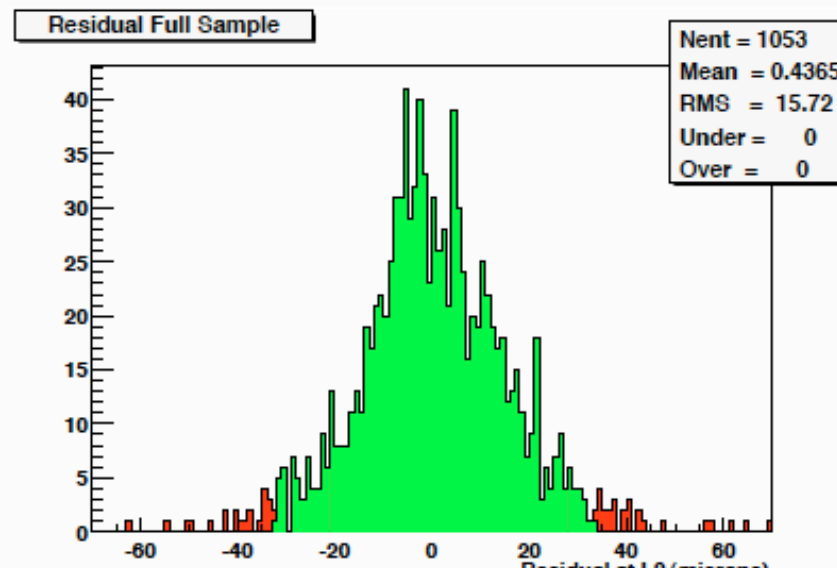
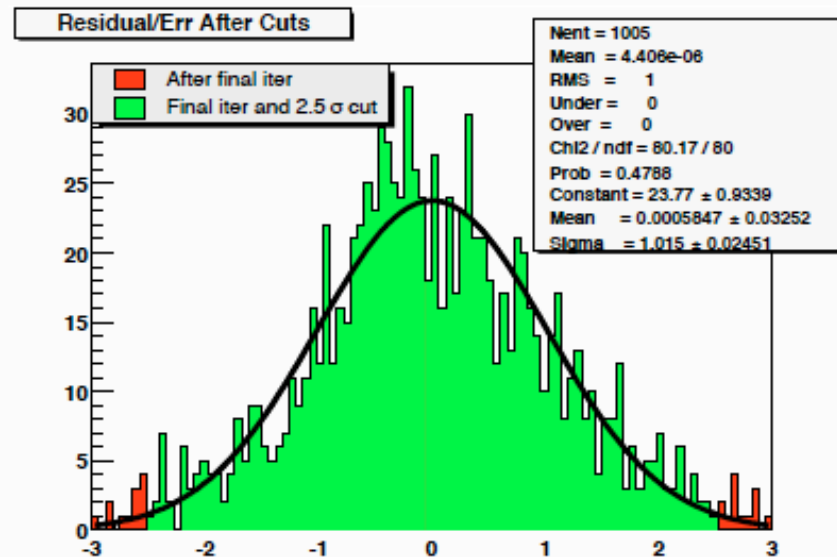


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Why is the 2 strip cluster
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1 strip cluster: somewhere
within that strip

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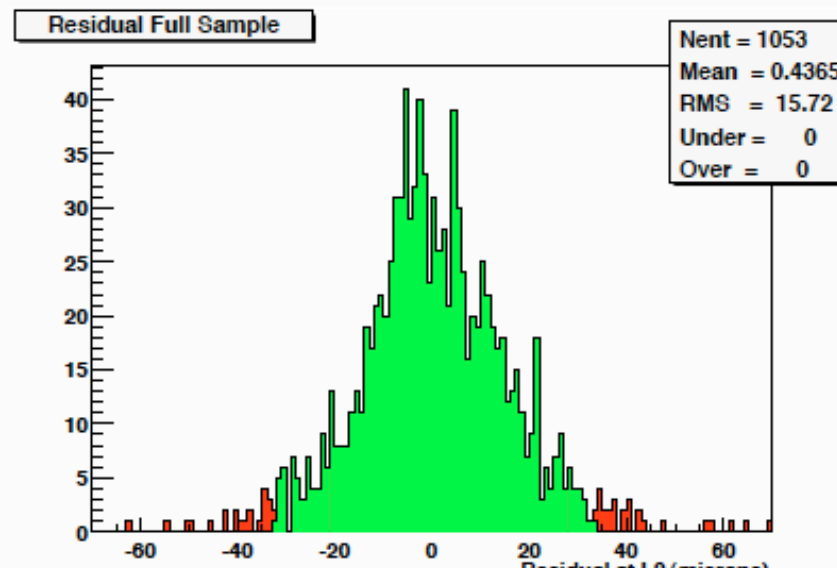
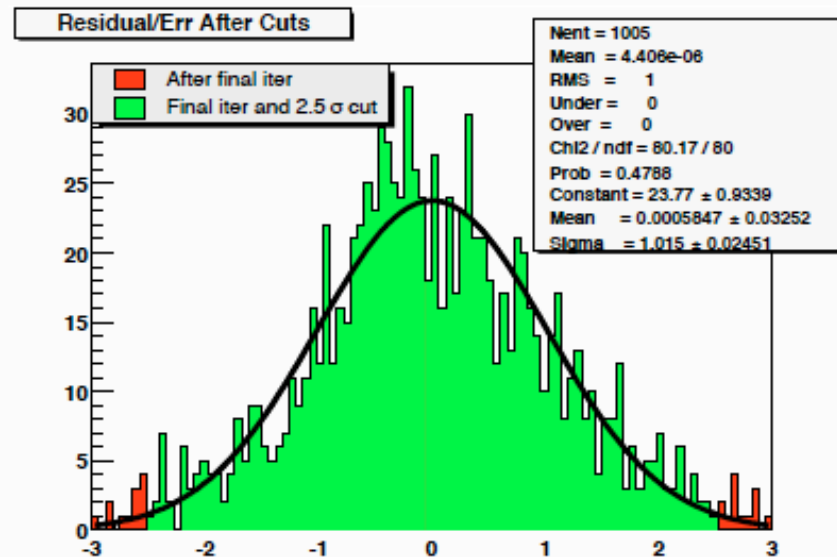


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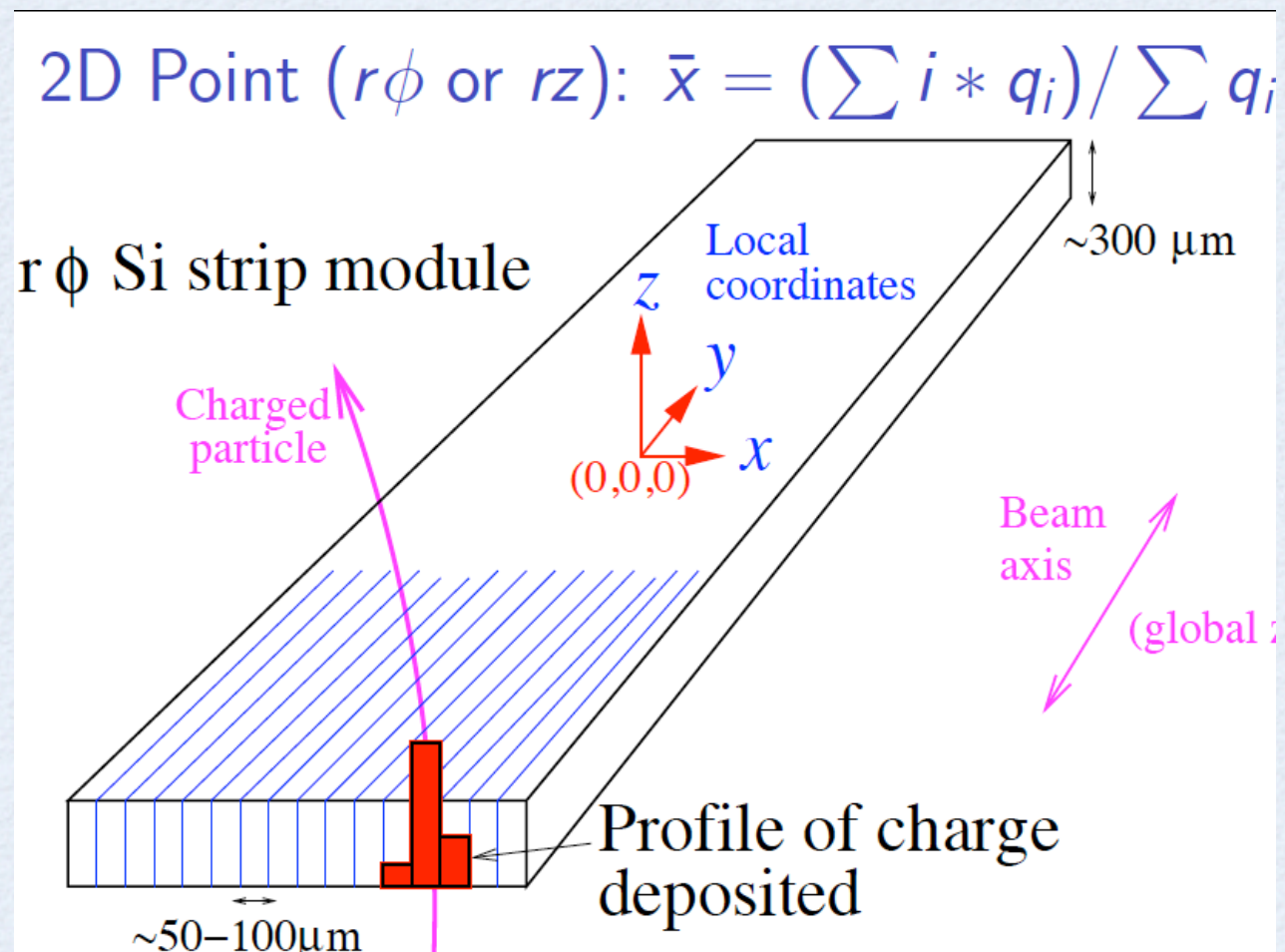
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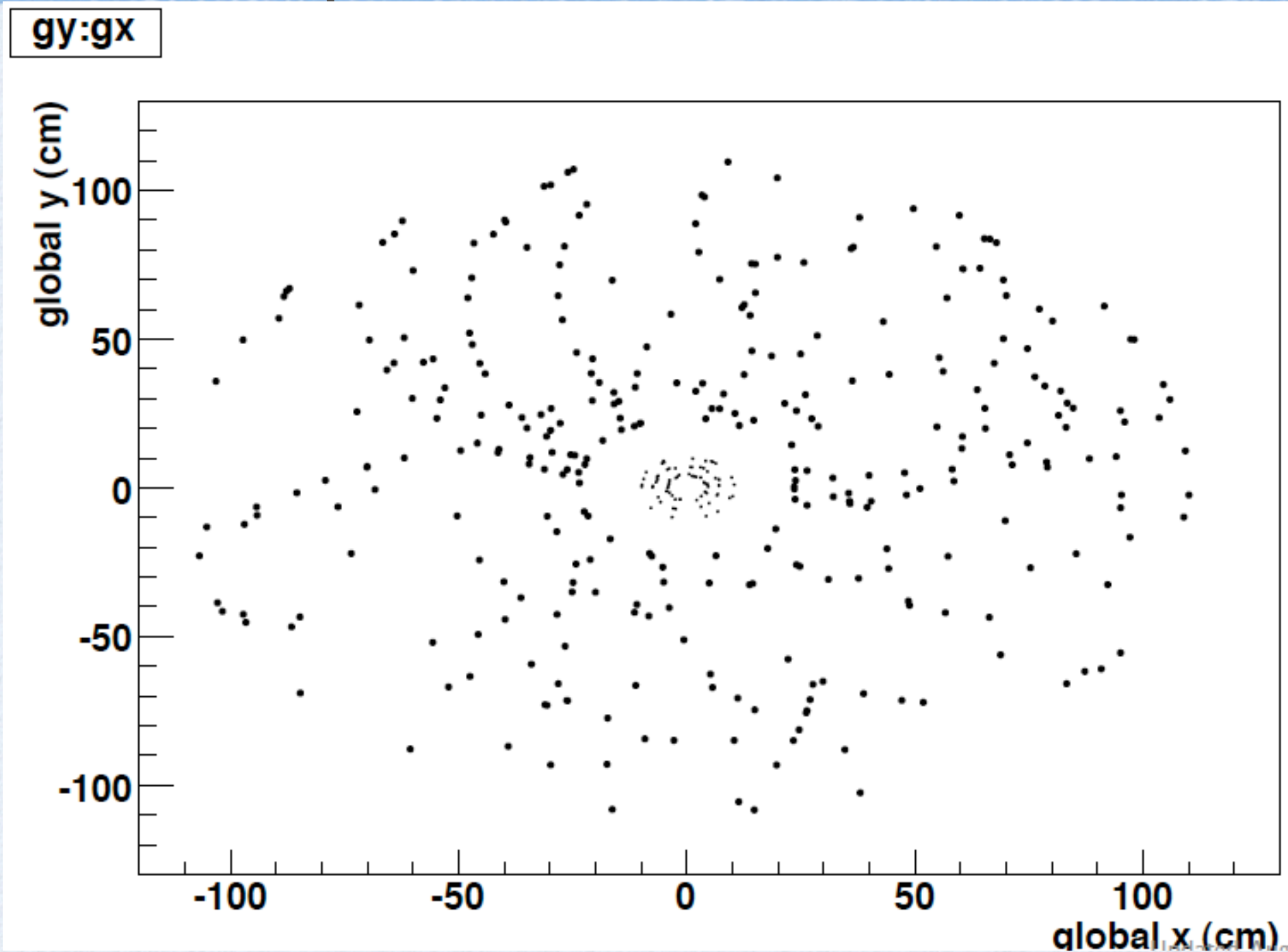
Why is the 2 strip cluster
the most precise?

why does resolution get better for
2 strip?

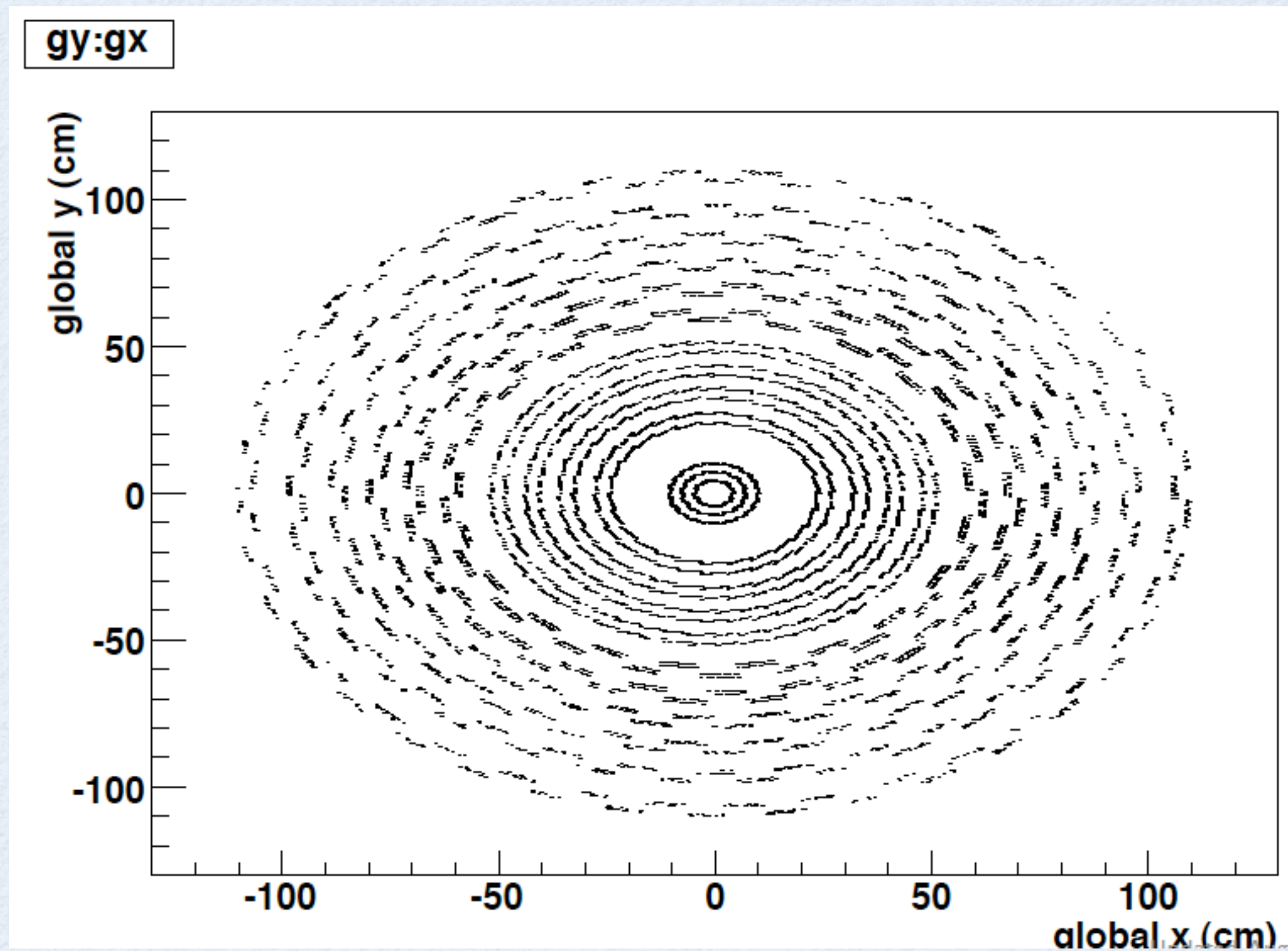


- Charge Sharing helps locate the position
- But too wide a cluster means less precision

CAN YOU FIND THE 50 GEV TRACK



HOW ABOUT NOW?



PATTERN RECOGNITION

- Typically pattern recognition is either 'inside-out' or 'outside-in'
 - You have to start with some idea of where the track should go to 'seed' the process

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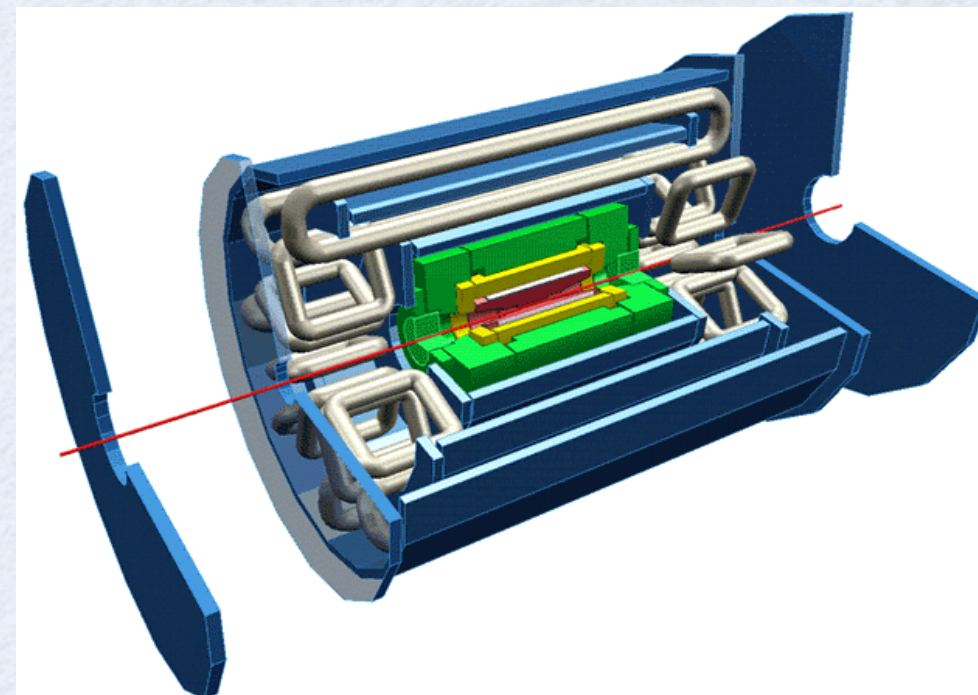
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 - Continue that process until you have found some criterion for a 'good track'

PATTERN RECOGNITION

- Typically pattern recognition is either 'inside-out' or 'outside-in'
 - You have to start with some idea of where the track should go to 'seed' the process
 - Take this seed and extrapolate it to other layers
 - Continue that process until you have found some criterion for a 'good track'
 - Once you select the hits on the track fit to those points

ATLAS MUONS

- Since muons penetrate material need to have a special system outside of the calorimeter
 - Large Volume Detector
 - Would like an independent momentum measurement \rightarrow B field (Toroidal)
- Over most of the detector we use drift tubes

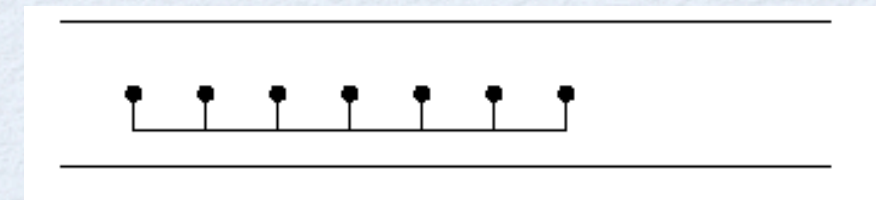
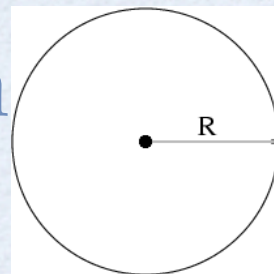


BASIC TECHNOLOGY

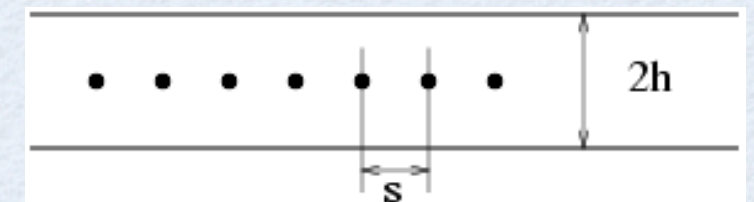
Tube Geiger- Müller, 1928

Multi Wire Geometry, in H. Friedmann 1949

- Volume of gas which a charged particle can ionize
- Voltage difference between wire and walls
- Charge drifts towards wire and signal is read out

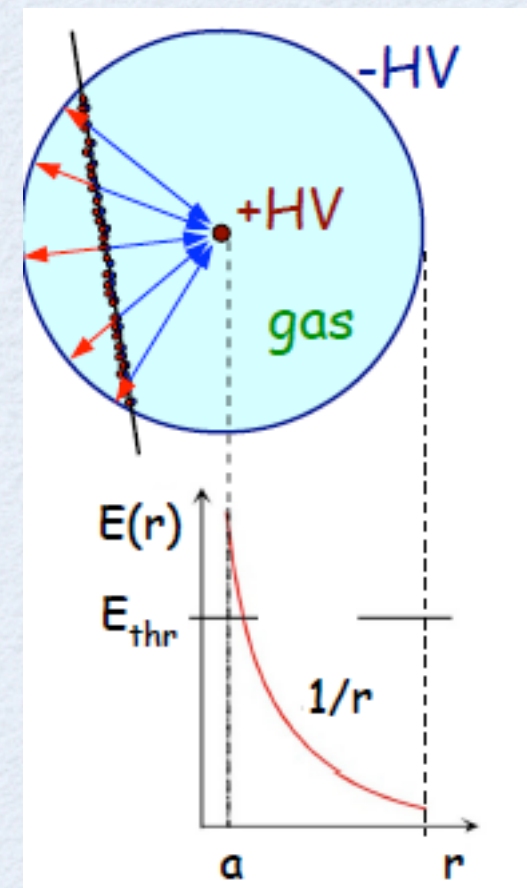


G. Charpak 1968



BASIC OPERATION

- few mm to few cm diameter
- thin wire run down the center under tension
- apply voltage to the wire (few kV)
- ionizing particle creates 'primary' ionization
 - ions drift toward wall
 - electrons drift toward wall
- Strong field near wire creates 'avalanche' effect as primary ionization causes secondary ionization



SIGNAL FORMATION

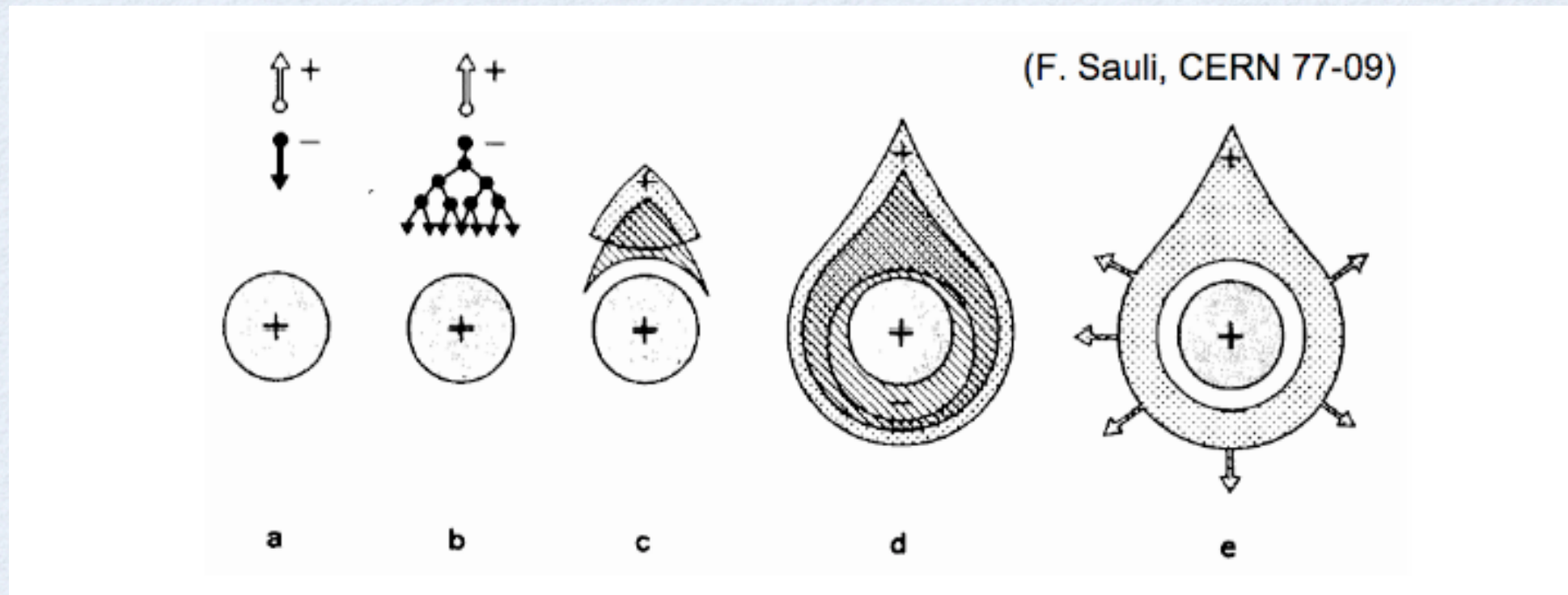


- Recall from basic E&M
- Moving charges cause change of potential energy and a voltage pulse on the wire

$$\Phi(r) = -\frac{V_0}{\ln\left(\frac{b}{a}\right)} \ln\frac{r}{a}$$

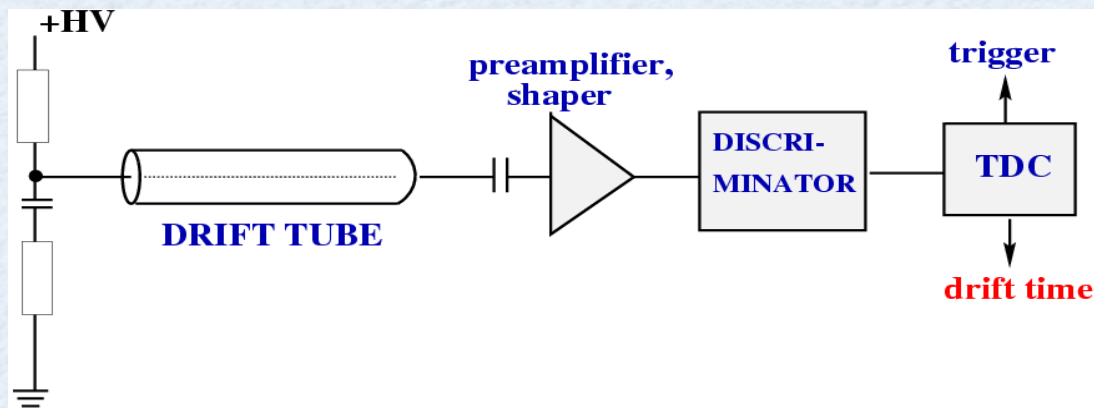
$$E(r) = \frac{V_0}{\ln\frac{b}{a}} \frac{1}{r}$$

AVALANCHE



Electrons move quickly to wire,
ions more slowly to tube surface

VOLTAGE PULSE



$$dW = qE(r)dr = CV_0dV$$

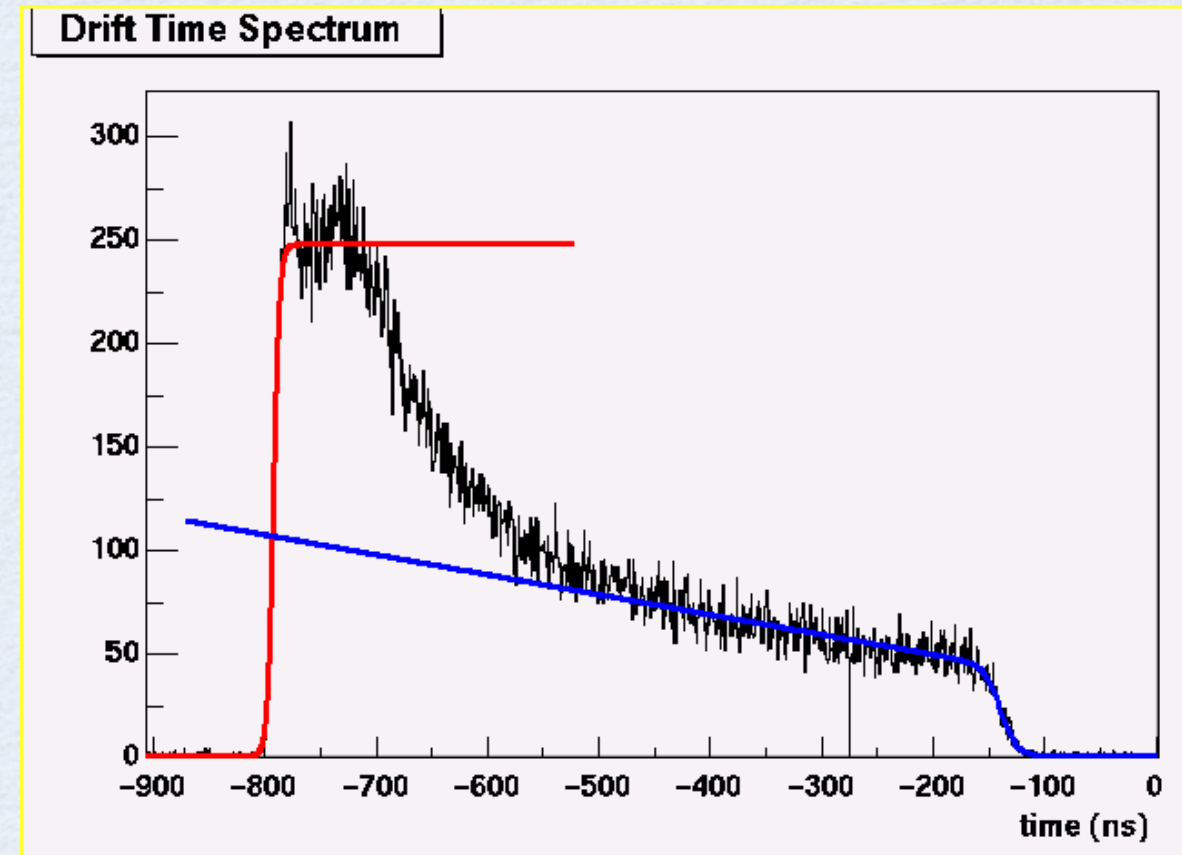
$$dV = \frac{q}{CV_0}E(r)dr$$

$$\Delta V = -\frac{q}{C}$$

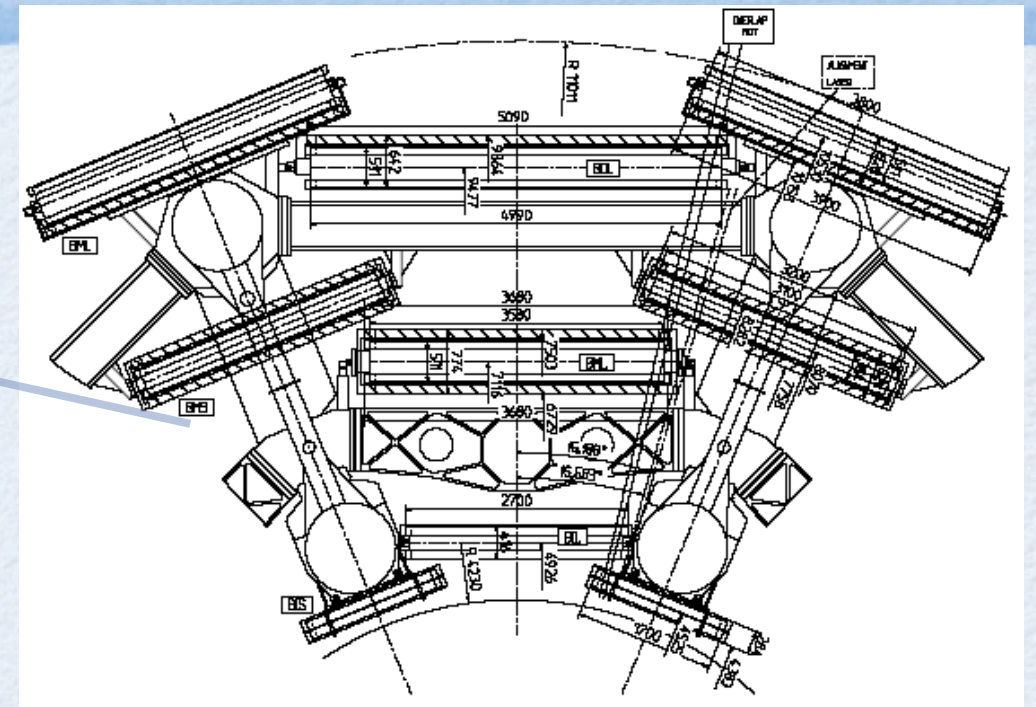
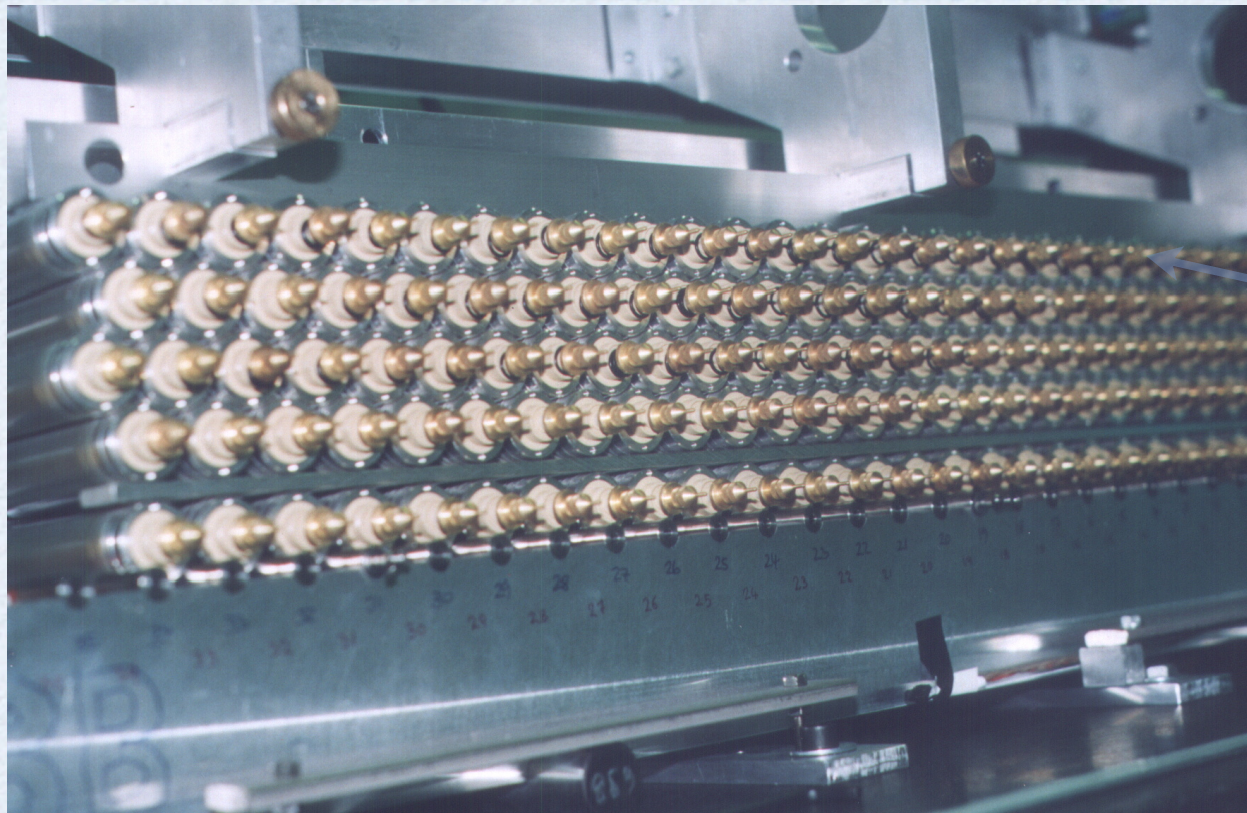
- Measure 2 basic quantities:
 - voltage drop and hence charge
 - time for leading edge of avalanche to reach the wire

TIME DISTRIBUTION

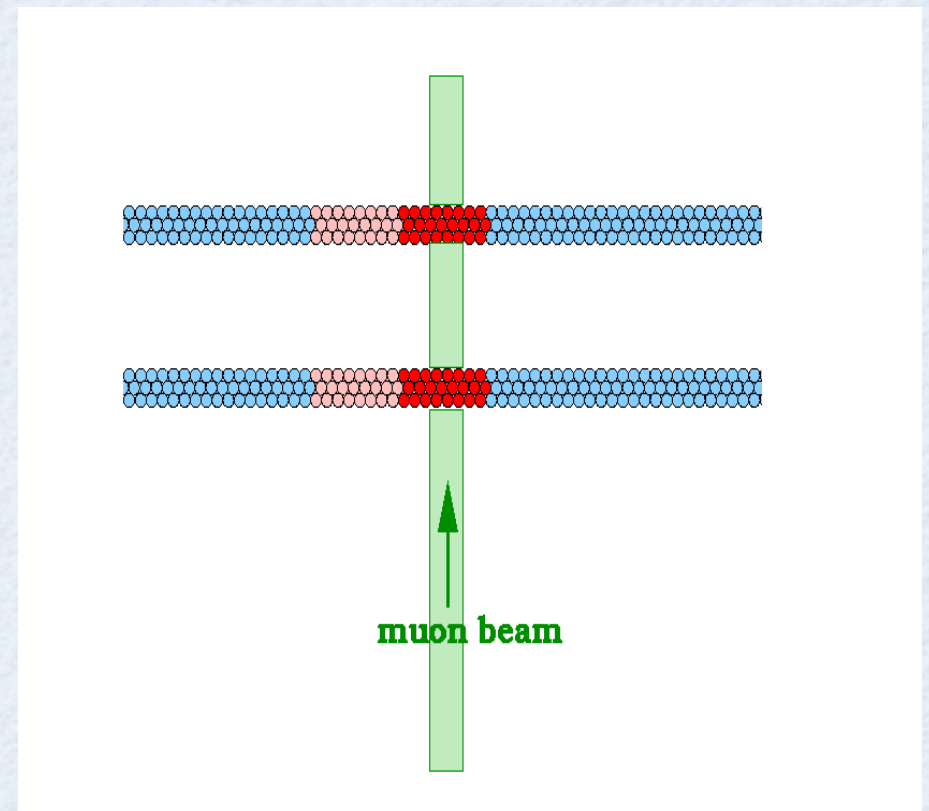
- What we measure is the drift time.
- By knowing the relationship between the time measured of the leading pulse and how far from the wire the ions we create a so called $r(t)$ function which tells us how far we are away from the wire



ARRANGEMENT

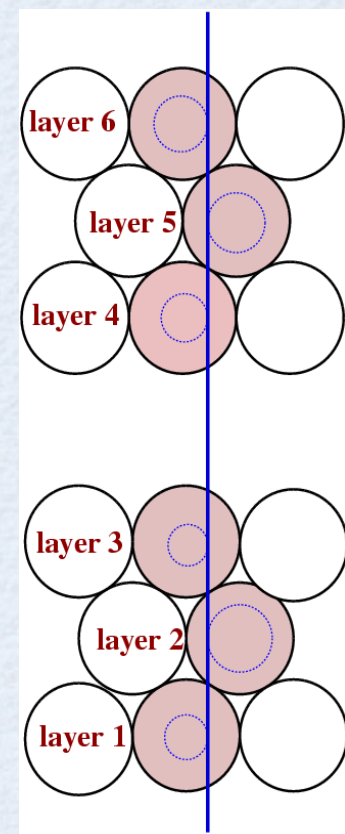


Arrange tubes in
chambers of layers to
make measurements at
different points along
trajectory



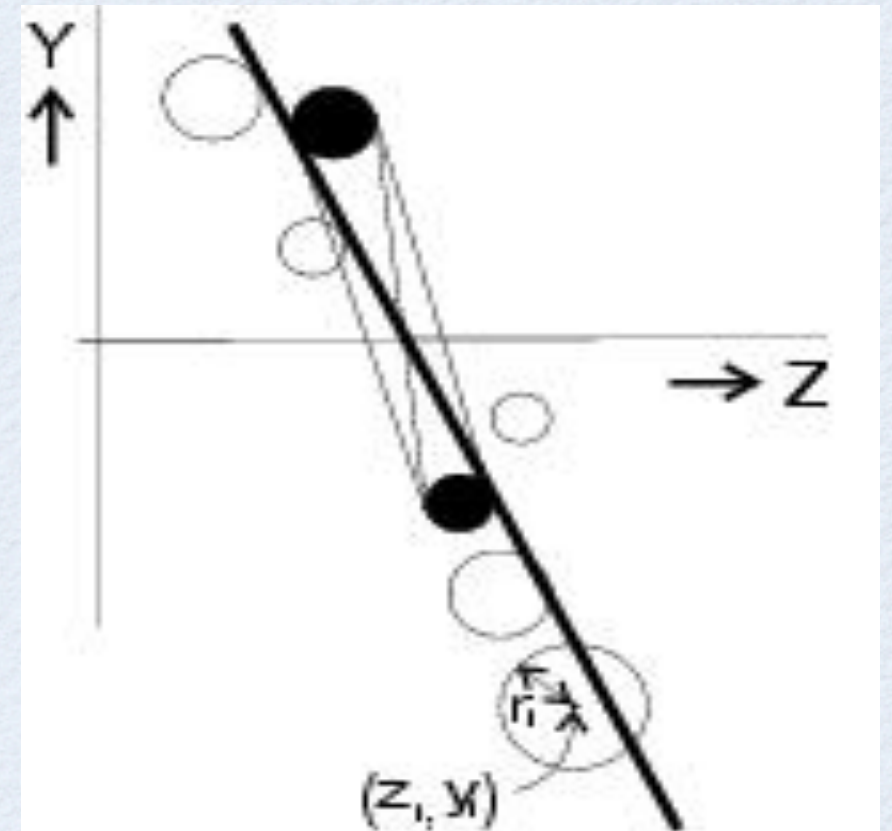
RECONSTRUCTING THE PATH

- For each tube that the muon passes through we get a time measurement from tube which we convert into a distance from the wire
 - Note - we don't actually know where along that circle the charge came from - called "Drift Circle"
 - This is resolved by pattern recognition!
- In this case the trajectory is fairly obvious



SEGMENT FITTING

- Over a small distance can approximate the trajectory as a straight line
- For each pair of hits:
 - Take outer most hits in a chamber and draw 4 tangential lines
 - Draw tangent lines to circle and see how far 'inside hits' are from line
- Fit hits to a line
- Take segment with most hits and best fit



HOW DO WE FIT?

$$\chi^2 = \sum_i^N \frac{(y_i - \lambda_i)^2}{\sigma_i^2}$$

- Recall our definition of a chi2
- If we have a model of our data we want to minimize that chi2

STRAIGHT LINE FIT

- here our model is that the particle goes in a straight line so that if we know the x position we can predict the y position with two parameters

$$y = a + bx$$

- a, b

DEFINITIONS

- For the linear case this just becomes:
- How do we minimize it ?

$$\chi^2(a, b) = \sum_i^N \left(\frac{y_i - a - bx_i}{\sigma_i} \right)^2$$

DEFINITIONS

- For the linear case this just becomes:
- How do we minimize it ?
 - Take derivative with respect to the parameters a and b so that we can find the values a and b which minimize the chi2
 - We are assuming we know the data y,x and the uncertainty on each point

$$\chi^2(a, b) = \sum_i^N \left(\frac{y_i - a - bx_i}{\sigma_i} \right)^2$$

$$0 = \frac{\delta \chi^2}{\delta a} = -2 \sum_i^N \frac{y_i - a - bx_i}{\sigma_i^2}$$

$$0 = \frac{\delta \chi^2}{\delta b} = -2 \sum_i^N \frac{x_i (y_i - a - bx_i)}{\sigma_i^2}$$

SOLVING IT

- First some definitions:
- Such that our minimization becomes:

$$0 = \frac{\delta \chi^2}{\delta a} = -2 \sum_i^N \frac{y_i - a - bx_i}{\sigma_i^2}$$

$$0 = \frac{\delta \chi^2}{\delta b} = -2 \sum_i^N \frac{x_i(y_i - a - bx_i)}{\sigma_i^2}$$

$$aS + bS_x = S_y$$

$$aS_x + bS_{xx} = S_{xy}$$

$$S = \sum_i^N \frac{1}{\sigma_i^2}$$

$$S_x = \sum_i^N \frac{x_i}{\sigma_i^2}$$

$$S_y = \sum_i^N \frac{y_i}{\sigma_i^2}$$

$$S_{xx} = \sum_i^N \frac{x_i^2}{\sigma_i^2}$$

$$S_{xy} = \sum_i^N \frac{x_i y_i}{\sigma_i^2}$$

SOLVING FOR A, B

Defining $\Delta = SS_{xx} - S_x^2$

$$a = \frac{S_{xx}S_y - S_xS_{xy}}{\Delta}$$

$$b = \frac{SS_{xy} - S_xS_y}{\Delta}$$

Homework: Show that
this is true!

NOT QUITE DONE...

- It is not good enough to have an estimate of the parameters a and b .

NOT QUITE DONE...

- It is not good enough to have an estimate of the parameters a and b .
- We must also have an estimate of the uncertainty on a and b and the 'goodness of fit'

PROPAGATION OF ERRORS

- Recall that for any function $f(a,b)$ we can expand in a Taylor series and write:

$$f \approx f^0 + \frac{\delta f}{\delta a} a + \frac{\delta f}{\delta b} b + \dots$$

- And hence

$$\sigma_f^2 = \left| \frac{\delta f}{\delta a} \right|^2 \sigma_a^2 + \left| \frac{\delta f}{\delta b} \right|^2 \sigma_b^2 + 2 \frac{\delta f}{\delta a} \frac{\delta f}{\delta b} \text{cov}_{ab}$$

PROPAGATION

$$\sigma_f^2 = \left| \frac{\delta f}{\delta a} \right|^2 \sigma_a^2 + \left| \frac{\delta f}{\delta b} \right|^2 \sigma_b^2 + 2 \frac{\delta f}{\delta a} \frac{\delta f}{\delta b} \text{cov}_{ab}$$

- Depends on functional dependence of the function

- eg f has is much more sensitive to a if

$$f(x; a) = a^5 x$$

- Then if

$$f(x; a) = a + x$$

FOR THE CASE AT HAND..

So

$$\sigma_f^2 = \sum_i^N \sigma_i^2 \left(\frac{\delta f}{\delta y_i} \right)^2$$

with

$$\frac{\delta a}{\delta y_i} = \frac{S_{xx} - S_x x_i}{\sigma_i^2 \Delta}$$

$$\frac{\delta b}{\delta y_i} = \frac{S x_i - S_x}{\sigma_i^2 \Delta}$$

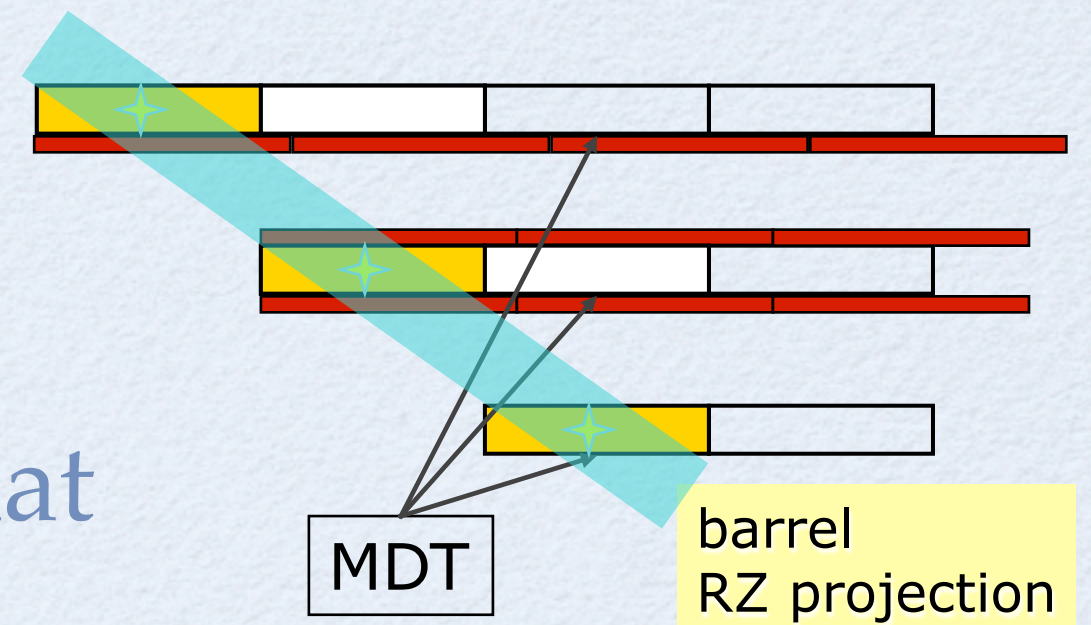
by summing:

$$\sigma_a^2 = \frac{S_{xx}}{\Delta}$$

$$\sigma_b^2 = \frac{S}{\Delta}$$

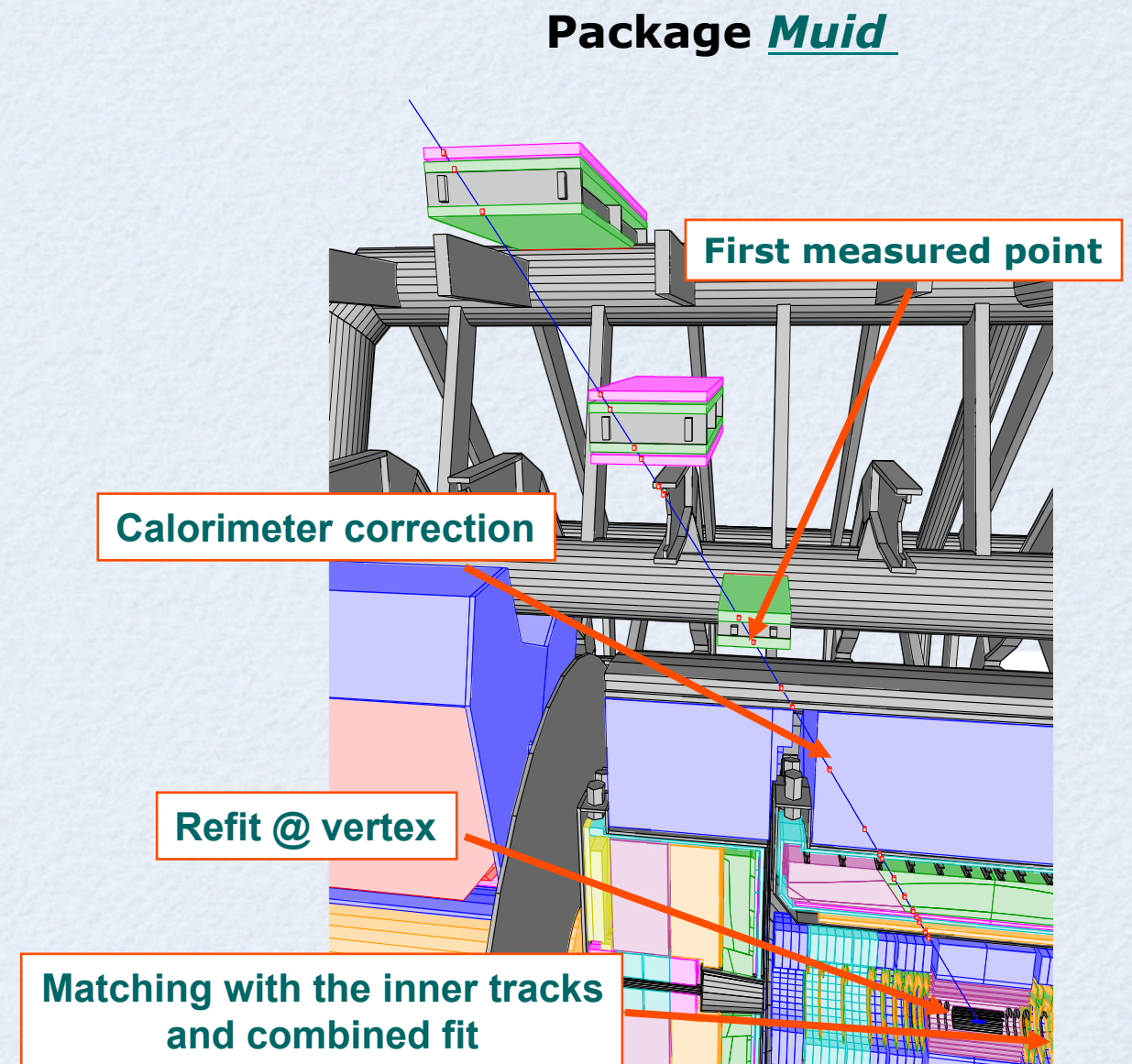
MATCH SEGMENTS

- Match segments from different layers of the spectrometer
- Look for pairs or triplets that point to each other
- Try all possibilities - and fit resulting hits to a track



FIT BACK TO ID

- Extrapolate track back to production point
- Match with track from inner detector
- Fit combined track



NEXT TIME

- More fun with likelihoods
- practice with some calculations